

Dates of Tests: June 26-July 05, 2017
Test Report S/N: LR500121707H
Test Site : LTA Co., Ltd.

XNO-6085R

Hanwha Techwin Co., Ltd.

Manufacturing Description	:	NETWORK CAMERA
Manufacturer	:	Hanwha Techwin Co., Ltd.
Model name	:	XNO-6085R
Additional model name	:	XNO-6085RP
Test Device Serial No.:	:	Identification
Directive	:	Electromagnetic Compatibility Directive 2014/30/EU
Rule Part(s)	:	EN 55032:2012/AC:2013
		EN 50130-4:2011+A1:2014
		EN 61000-3-2:2014
		EN 61000-3-3:2013
Data of reissue	:	July 07, 2017

The test was supervised by:



Yong-Cheol, Wang, Manager



Hyeon Woo Lee, Test Engineer

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Revision	Date of issue	Test report No.	Description
0	07.07.2017	LR500121707H	Initial

TABLE OF CONTENTS

1. GENERAL INFORMATION'S	4
2. INFORMATION'S ABOUT TEST ITEM	5
3. TEST REPORT	7
3.1 SUMMARY OF TESTS	7
3.2 EMISSION	8
3.2.1 Disturbance Voltage at the mains terminals	8
3.2.2 Radiated disturbances	20
3.2.3 Harmonic Current Emissions	31
3.2.4 Voltage Fluctuations and Flicker	40
3.3 IMMUNITY	43
3.3.1 Electrostatic discharge.....	43
3.3.2 RF Electromagnetic Field	45
3.3.3 Electrical fast transients	46
3.3.4 Surge.....	47
3.3.5 Conducted Disturbances, Induced by Radio-Frequency Fields	49
3.3.6 Main supply voltage dips, short interruptions	50
3.3.7 Main supply voltage variations	51
 APPENDIX	
APPENDIX A TEST EQUIPMENT USED FOR TESTS	52
APPENDIX B PERFORMANCE CRITERIA	55
APPENDIX C MEASUREMENT UNCERTAINTY	58
APPENDIX D PHOTOGRAPH	61

1. General information's

1-1 Test Performed

Company name : **LTA Co., Ltd.**
 Address : 243, Jubug-ri, Yangji-Myeon, Yongin-Si, Kyunggi-Do, Korea. 449-822
 Web site : <http://www.ltalab.com>
 E-mail : chahn@ltalab.com
 Telephone : +82-31-323-6008
 Facsimile : +82-31-323-6010

Quality control in the testing laboratory is implemented as per ISO/IEC 17025 which is the “General requirements for the competents of calibration and testing laboratory”.

1-2 Accredited agencies

LTA Co., Ltd. is approved to perform EMC testing by the following agencies:

Agency	Country	Accreditation No.	Validity	Reference
NVLAP	U.S.A	200723-0	2017-09-30	ECT accredited Lab.
RRA	KOREA	KR0049	-	EMC accredited Lab.
FCC	U.S.A	649054	2019-04-13	FCC CAB
VCCI	JAPAN	R-2133(10 m), C-2307	2017-06-21	VCCI registration
VCCI	JAPAN	T-2009	2017-12-23	VCCI registration
VCCI	JAPAN	G-847	2018-12-13	VCCI registration
IC	CANADA	5799A-1	2019-11-07	IC filing
KOLAS	KOREA	NO.551	2017-01-08	KOLAS accredited Lab.

2. Information's about test item

2-1 Client/ Manufacturer

Company name : Hanwha Techwin Co., Ltd.
 Address : 6, Pangyo-ro 319 Beon-gil, Bundang-gu, Seongnam-si, Gyeonggi-do, 13488, KOREA
 Telephone / Facsimile : +82-70-7147-8753

Factory #1

Company name : Hanwha Techwin (Tianjin) Co., Ltd.
 Address : No.11 Weiliu Rd, Micro-Electronic Industrial Park, TEDA, Tianjin, 300385, People's Republic of China

Factory #2

Company name : HANWHA TECHWIN SECURITY VIETNAM CO., LTD.
 Address : Lot O-2, Que Vo Industrial Zone extended area, Nam Son commune, Bac Ninh city, Bac Ninh province, Vietnam

Factory #3

Company name : D-TECH CO., LTD.
 Address : 173-25, Saneop-ro, Gwonseon-gu, Suwon-si, Gyeonggi-do, Korea (Suwon Industrial Complex)

2-2 Equipment Under Test (EUT)

Class : A
 Category : NETWORK CAMERA
 Model name : XNO-6085R
 Additional Model Name : XNO-6085RP
 Serial number : Identification
 Date of receipt : June 21, 2017
 EUT condition : Pre-production, not damaged
 Interface ports : AC IN, DC IN, Video, Micro USB, Audio IN, Audio OUT, ALARM, GND, Micro SD Slot, Network
 Power rating : DC 12 V, AC 24 V
 Firmware version : XXXX

2-3 Modification

-NONE

2-4 Model Specification

-NONE

2-5 Test conditions

Temp. / Humid. / Pressure : +(19-23) °C / (41-51) %RH / (100.1-100.2) kPa
 Tested Model : XNO-6085R
 Test mode : Recording (AC, DC, PoE) mode
 Power supply : AC 230 V / 50 Hz

2-6 Ancillary Equipment / Recording (AC) mode

Equipment	Model No.	Serial No.	Manufacturer
Notebook	P2416D	N/A	Dell
Monitor	SMC-150F	N/A	Samsung
Mobile Phone	SCH-E330S	N/A	Samsung
Earphone	N/A	N/A	N/A
Micro SD Card	N/A	N/A	N/A
AC Adapter	DRC-241500AC	N/A	Samsung

/ Recording (DC) mode

Equipment	Model No.	Serial No.	Manufacturer
Notebook	P2416D	N/A	Dell
Monitor	SMC-150F	N/A	Samsung
Mobile Phone	SCH-E330S	N/A	Samsung
Earphone	N/A	N/A	N/A
Micro SD Card	N/A	N/A	N/A
DC Adapter	2ACB022F	N/A	N/A

/ Recording (PoE) mode

Equipment	Model No.	Serial No.	Manufacturer
Notebook	P2416D	N/A	Dell
Monitor	SMC-150F	N/A	Samsung
Mobile Phone	SCH-E330S	N/A	Samsung
Earphone	N/A	N/A	N/A
Micro SD Card	N/A	N/A	N/A
PoE Injector	PSE305	N/A	N/A

3. Test Report

3.1 Summary of tests

Parameter	Applied Standard	Status
I. Emission		
Radiated Emission	EN 55032:2012/AC:2013	C
Conducted Emission	EN 55032:2012/AC:2013	C
Harmonic Current Emission	EN 61000-3-2:2014	C
Voltage Fluctuations and Flicker	EN 61000-3-3:2013	C
II. Immunity		
Electrostatic Discharge	EN 61000-4-2:2009	C
RF Electromagnetic field	EN 61000-4-3:2006/A2:2010	C
Fast Transients Common mode	EN 61000-4-4:2012	C
Surges, line to line and line to ground	EN 61000-4-5:2014	C
RF common mode	EN 61000-4-6:2014	C
Voltage dips and Interruptions	EN 61000-4-11:2004	C
Main supply voltage variations	EN 50130-4:2011	C

Note 1: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

Note 2: The device is operated by DC Power.

Note 3: The data in this test report are traceable to the national or international standards.

3.2 EMISSION

3.2.1 Conducted emissions

Definition:

The test assesses the ability of the EUT to limit its internal noise from being present on the AC mains Power In/Output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Measurement Frequency range	: 150 kHz - 30MHz
Test method	: EN 55032:2012/AC:2013
Measurement RBW	: 9 kHz
Test mode	: Recording (AC, DC, PoE) mode
Result	: Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)
- No other emissions were detected at a level greater than 20 dB below limit

A sample calculation:

COR. F (correction factor)= LISN Insertion loss + Cable loss

Emission Level= meter reading + COR.F

Limits for conducted disturbance at the mains ports of class A ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	79 dBuV	66 dBuV
(0.5 – 30) MHz	73 dBuV	60 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15MHz to 0.5MHz

Limits for conducted disturbance at the mains ports of class B ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	(66 – 56) dBuV	(56 - 46) dBuV
(0.5 – 5) MHz	56 dBuV	46 dBuV
(5 – 30) MHz	60 dBuV	50 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15 MHz to 0.5 MHz

TEST EQUIPMENT USED: 01, 02, 03, 07, 08, 09, 10

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class A equipment

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 – 0.5) MHz	(97 – 87) dBuV	(84 – 74) dBuV	(53 – 43) dBuV	(40 – 30) dBuV
(0.5 – 30) MHz	87 dBuV	74 dBuV	43 dBuV	30 dBuV

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I = 44$ dB)

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class B equipment

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 – 0.5) MHz	(84 – 74) dBuV	(74 – 64) dBuV	(40 – 30) dBuV	(30 – 20) dBuV
(0.5 – 30) MHz	74 dBuV	64 dBuV	30 dBuV	20 dBuV

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I = 44$ dB)

TEST EQUIPMENT USED: 01, 02, 03, 07, 08, 09, 10

Conducted emissions (LINE) / Recording (AC) mode



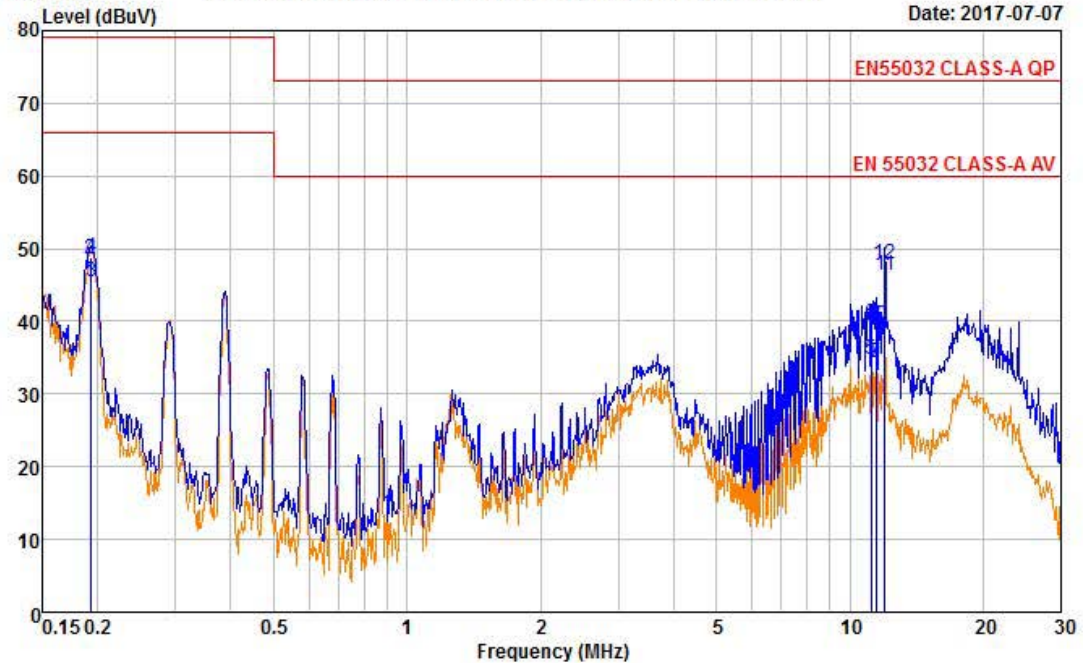
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449-822 Korea
Tel: +82-31-3236008, 9
Fax: +82-31-3236010

EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : LINE
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 2799

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3363)

Date: 2017-07-07



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
0.193	38.40	35.13	10.09	48.49	45.22	79.00	66.00	30.51	20.78
0.194	38.61	35.33	10.09	48.70	45.42	79.00	66.00	30.30	20.58
11.165	29.07	24.18	10.67	39.74	34.85	73.00	60.00	33.26	25.15
11.457	28.89	23.65	10.68	39.57	34.33	73.00	60.00	33.43	25.67
11.458	28.82	23.67	10.68	39.50	34.35	73.00	60.00	33.50	25.65
12.001	37.17	35.55	10.72	47.89	46.27	73.00	60.00	25.11	13.73

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (NEUTRAL) / Recording (AC) mode



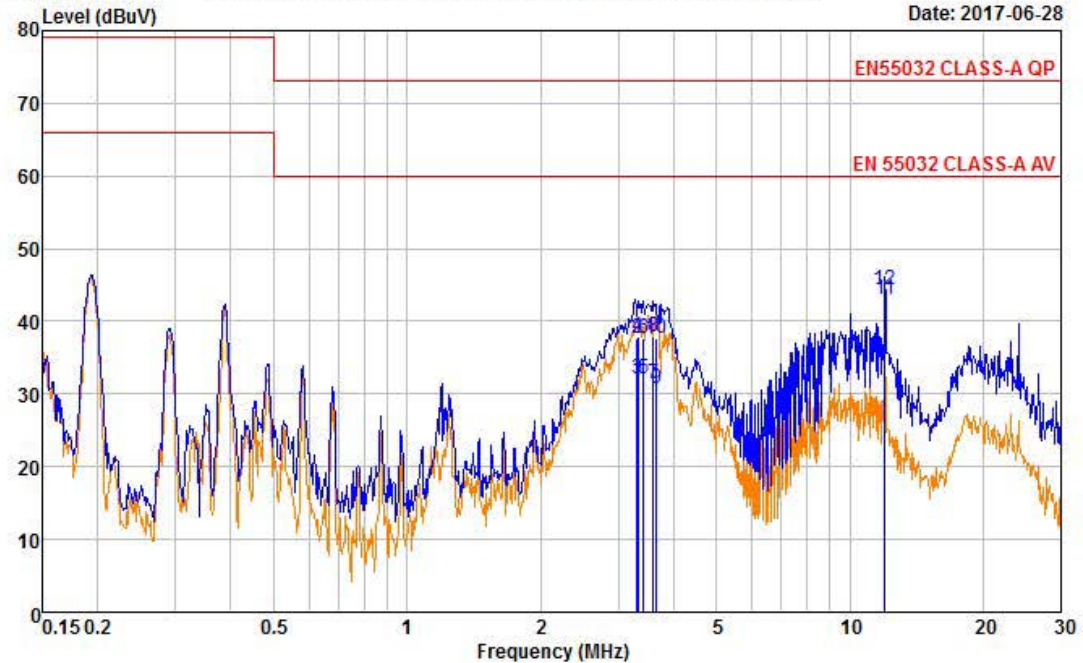
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449-822 Korea
Tel:+82-31-3236008,9
Fax:+82-31-3236010

EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : NEUTRAL
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 2795

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Date: 2017-06-28



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
3.306	27.33	21.66	10.29	37.62	31.95	73.00	60.00	35.38	28.05
3.315	27.61	21.84	10.29	37.90	32.13	73.00	60.00	35.10	27.87
3.426	27.33	21.89	10.29	37.62	32.18	73.00	60.00	35.38	27.82
3.595	27.59	21.04	10.30	37.89	31.34	73.00	60.00	35.11	28.66
3.662	27.46	20.44	10.30	37.76	30.74	73.00	60.00	35.24	29.26
12.000	33.65	32.21	10.72	44.37	42.93	73.00	60.00	28.63	17.07

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_10 M) / Recording (AC) mode



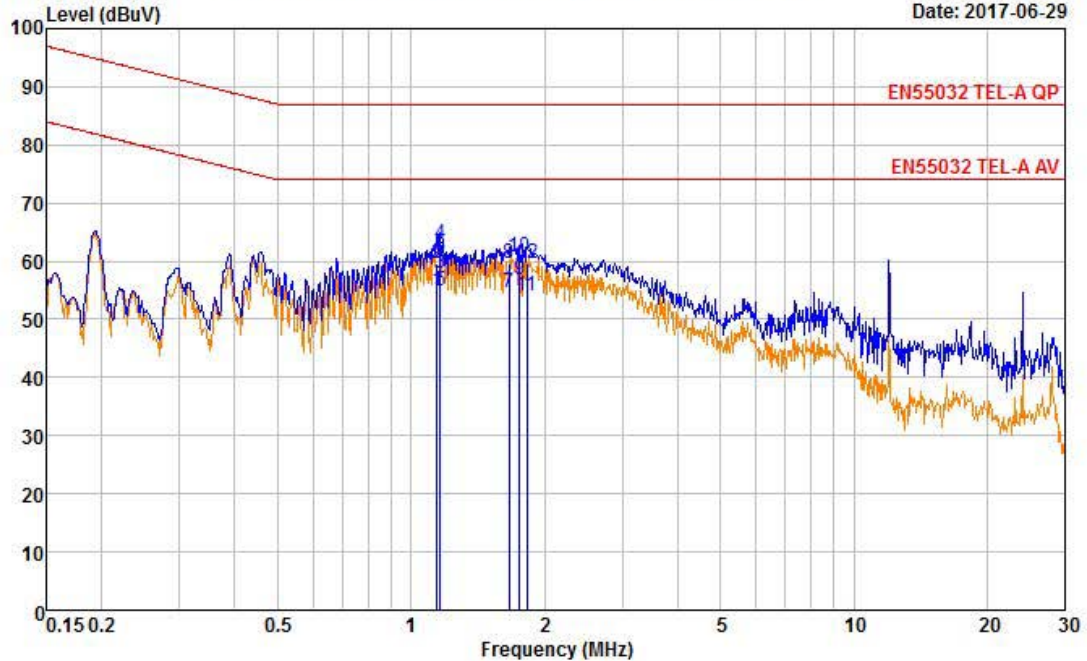
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449-822 Korea
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EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : TEL_10M
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 2959

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
1.145	40.02	35.21	19.69	59.71	54.90	87.00	74.00	27.29	19.10
1.163	43.39	38.31	19.69	63.08	58.00	87.00	74.00	23.92	16.00
1.166	40.97	35.26	19.68	60.65	54.94	87.00	74.00	26.35	19.06
1.664	40.02	35.10	19.63	59.65	54.73	87.00	74.00	27.35	19.27
1.762	41.20	37.29	19.63	60.83	56.92	87.00	74.00	26.17	17.08
1.824	40.05	34.46	19.62	59.67	54.08	87.00	74.00	27.33	19.92

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_1000 M) / Recording (AC) mode



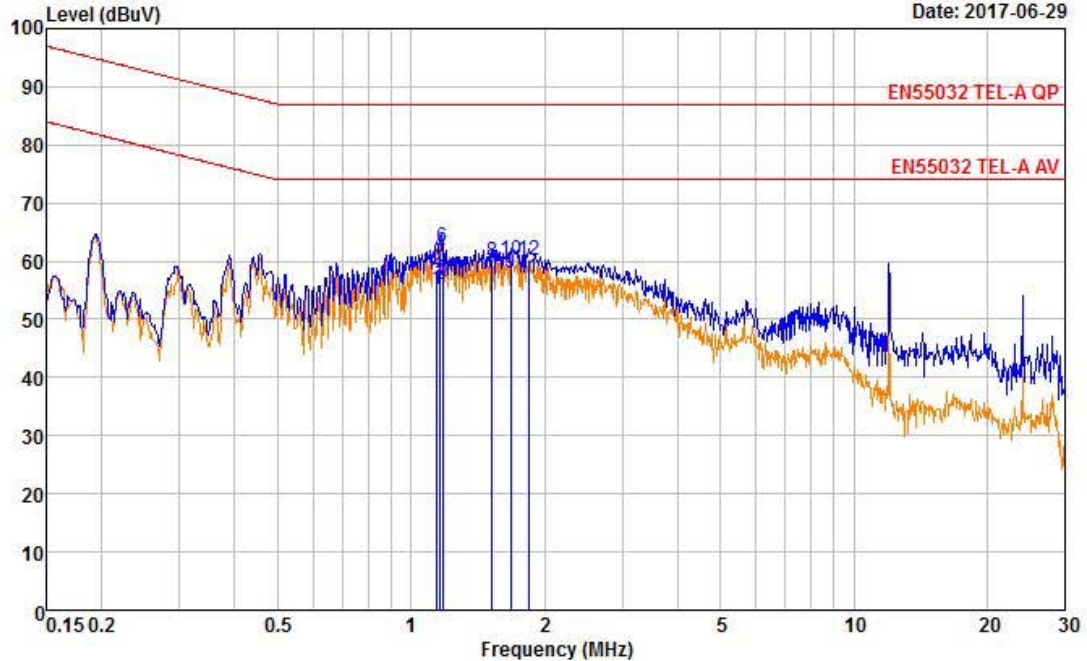
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449-822 Korea
Tel: +82-31-3236008, 9
Fax: +82-31-3236010

EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : TEL_1000M
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 2963

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
1.143	39.29	35.88	19.28	58.57	55.16	87.00	74.00	28.43	18.84
1.163	41.97	36.66	19.28	61.25	55.94	87.00	74.00	25.75	18.06
1.181	43.00	37.48	19.27	62.27	56.75	87.00	74.00	24.73	17.25
1.522	40.75	38.72	19.25	60.00	57.97	87.00	74.00	27.00	16.03
1.681	41.03	38.77	19.23	60.26	58.00	87.00	74.00	26.74	16.00
1.840	40.87	37.99	19.22	60.09	57.21	87.00	74.00	26.91	16.79

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (LINE) / Recording (DC) mode



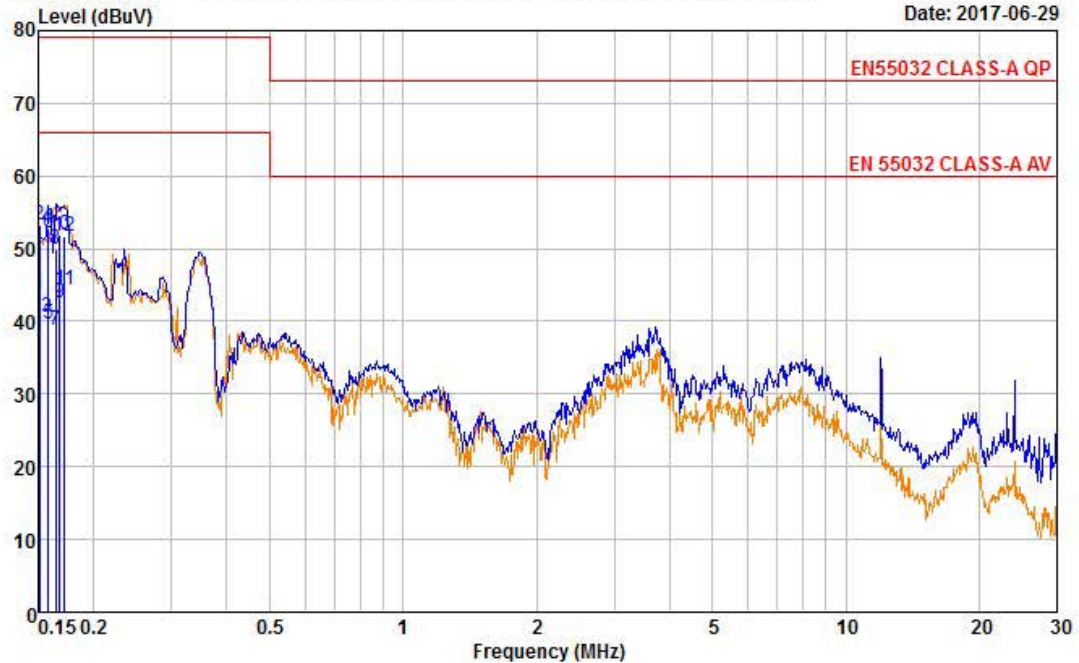
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449-822 Korea
Tel: +82-31-3236008, 9
Fax: +82-31-3236010

EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : LINE
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 3011

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
0.151	43.21	33.47	10.10	53.31	43.57	79.00	66.00	25.69	22.43
0.157	42.65	30.55	10.10	52.75	40.65	79.00	66.00	26.25	25.35
0.158	42.06	29.59	10.10	52.16	39.69	79.00	66.00	26.84	26.31
0.164	39.74	28.62	10.09	49.83	38.71	79.00	66.00	29.17	27.29
0.168	41.88	32.52	10.10	51.98	42.62	79.00	66.00	27.02	23.38
0.172	41.59	34.29	10.10	51.69	44.39	79.00	66.00	27.31	21.61

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (NEUTRAL) / Recording (DC) mode

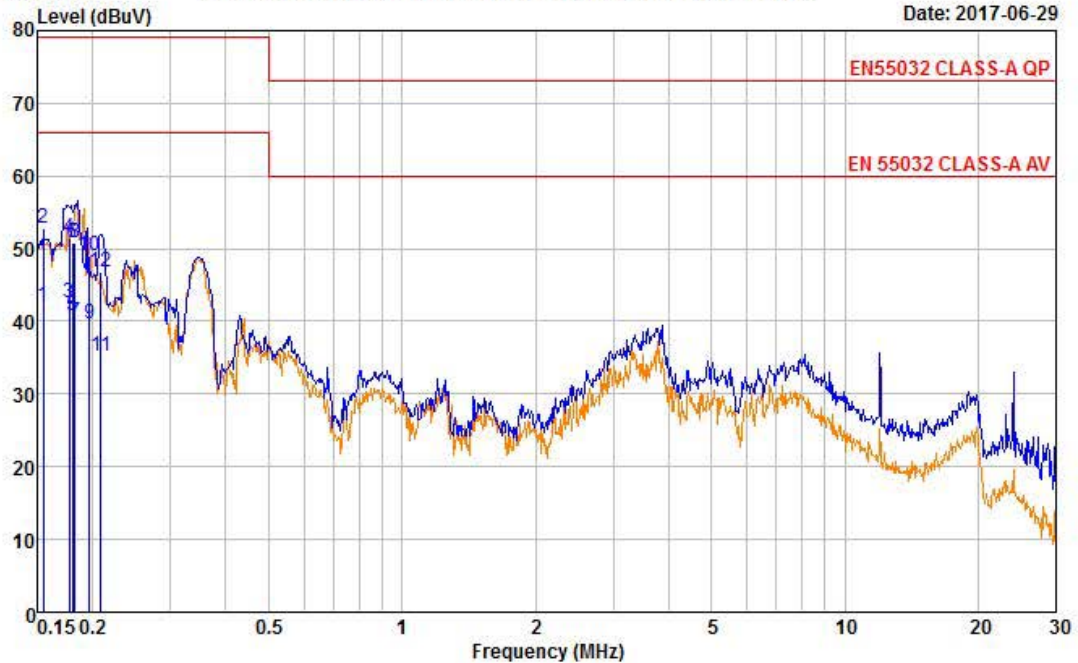
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EUT / Model No. : XNO-6085R* (*N:NT/P:PAL)	Phase : NEUTRAL
Test Mode : Recording mode	Test Power : 230 / 50
Temp. / Humi. : 21 / 45	Test Engineer : LEE H W

Data: 3007

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
0.155	42.75	31.99	10.15	52.90	42.14	79.00	66.00	26.10	23.86
0.177	41.22	32.36	10.16	51.38	42.52	79.00	66.00	27.62	23.48
0.180	40.68	30.61	10.16	50.84	40.77	79.00	66.00	28.16	25.23
0.183	40.69	29.64	10.16	50.85	39.80	79.00	66.00	28.15	26.20
0.196	38.88	29.59	10.16	49.04	39.75	79.00	66.00	29.96	26.25
0.209	36.64	25.01	10.17	46.81	35.18	79.00	66.00	32.19	30.82

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_10 M) / Recording (DC) mode



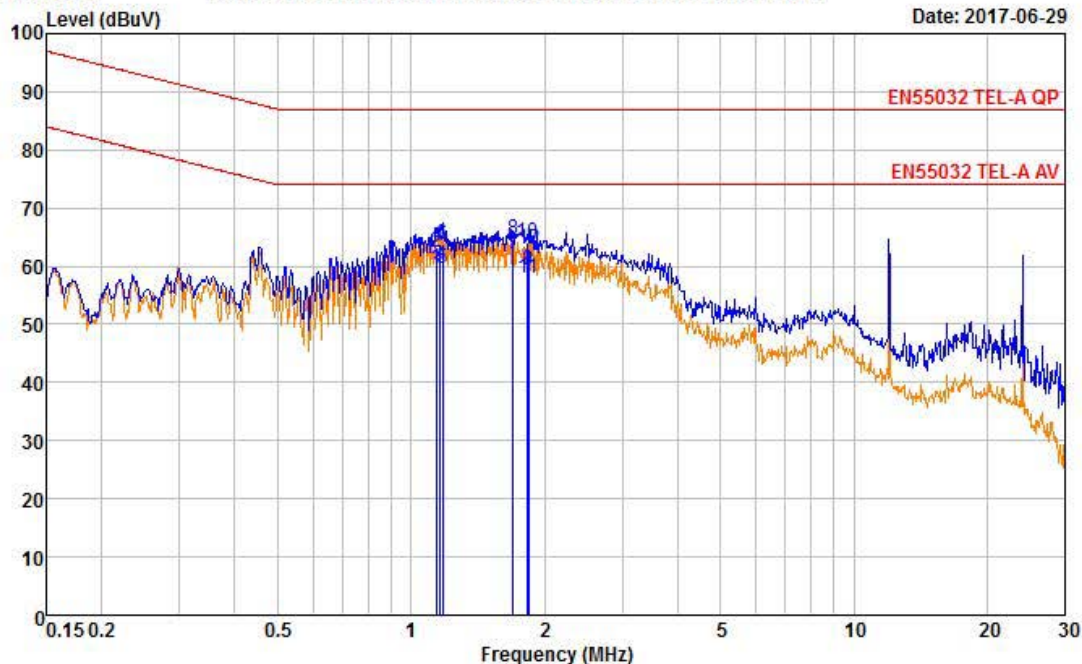
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EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : TEL_10M
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 2991

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
1.139	42.66	40.04	19.69	62.35	59.73	87.00	74.00	24.65	14.27
1.159	43.75	40.59	19.69	63.44	60.28	87.00	74.00	23.56	13.72
1.176	44.17	40.00	19.68	63.85	59.68	87.00	74.00	23.15	14.32
1.697	44.94	42.35	19.63	64.57	61.98	87.00	74.00	22.43	12.02
1.838	44.43	39.82	19.62	64.05	59.44	87.00	74.00	22.95	14.56
1.840	43.44	38.35	19.62	63.06	57.97	87.00	74.00	23.94	16.03

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_1000 M) / Recording (DC) mode



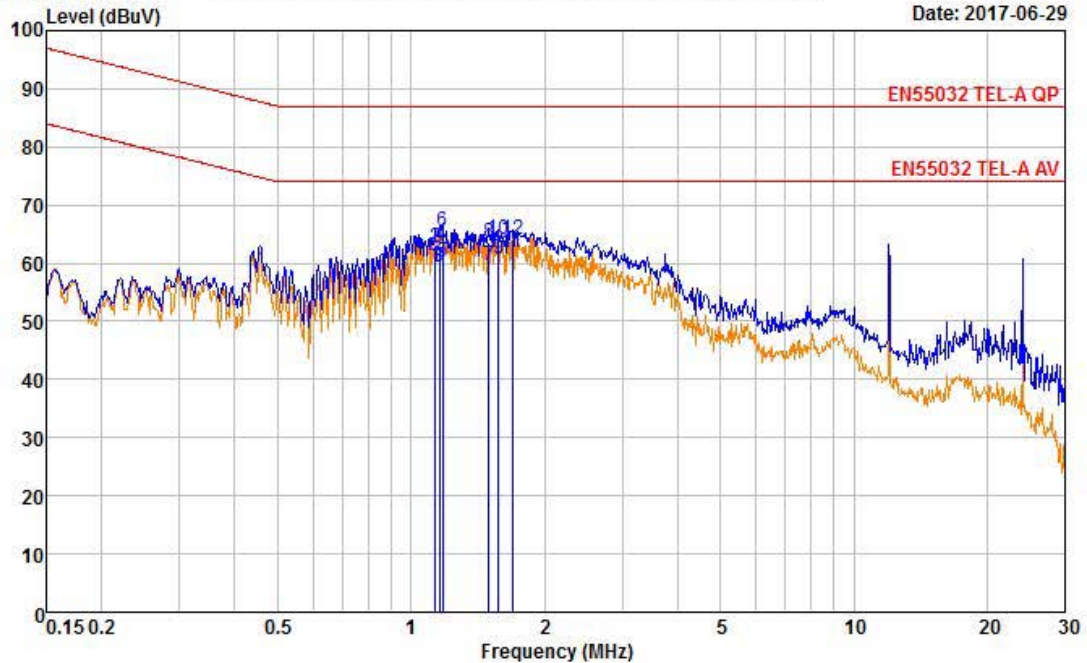
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Fax:+82-31-3236010

EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : TEL_1000M
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 2995

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
1.137	43.34	40.20	19.28	62.62	59.48	87.00	74.00	24.38	14.52
1.160	43.80	39.95	19.28	63.08	59.23	87.00	74.00	23.92	14.77
1.179	46.12	40.98	19.27	65.39	60.25	87.00	74.00	21.61	13.75
1.496	44.14	40.38	19.25	63.39	59.63	87.00	74.00	23.61	14.37
1.577	44.90	41.53	19.24	64.14	60.77	87.00	74.00	22.86	13.23
1.697	44.83	42.51	19.23	64.06	61.74	87.00	74.00	22.94	12.26

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_10 M) / Recording (PoE) mode



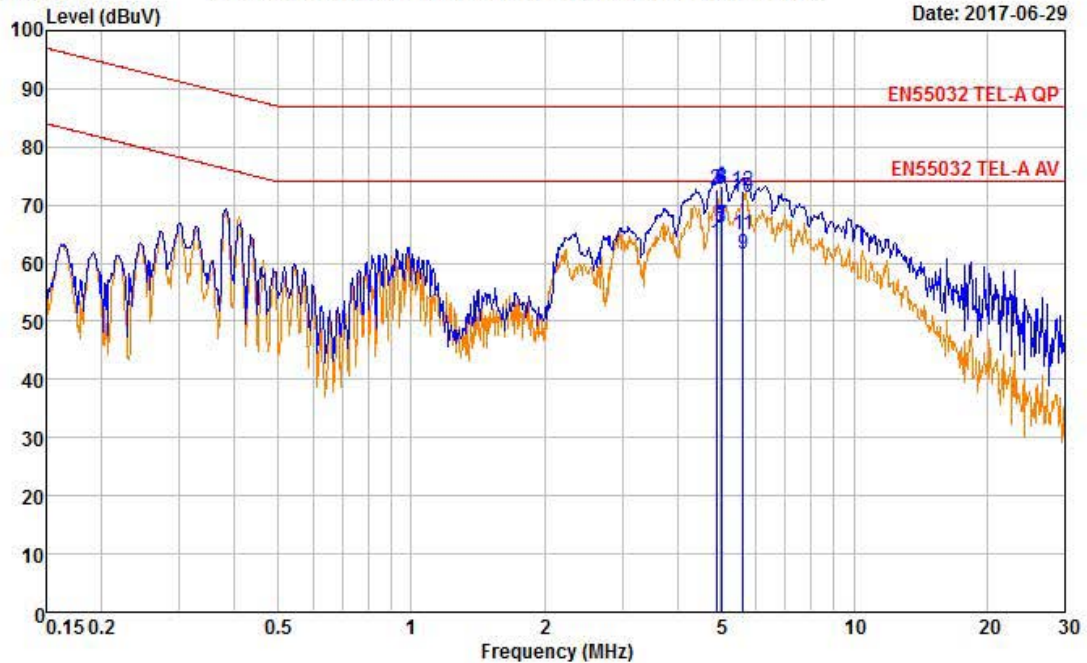
4, Songjuro 236 Beon-gil, Yangji-myeon
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449-822 Korea
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Fax:+82-31-3236010

EUT / Model No. : XNO-6085R* (*N:NT/P:PAL) Phase : TEL_10M
Test Mode : Recording mode Test Power : 230 / 50
Temp. / Humi. : 21 / 45 Test Engineer : LEE H W

Data: 2967

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
4.891	53.13	43.77	19.66	72.79	63.43	87.00	74.00	14.21	10.57
5.019	53.47	46.29	19.65	73.12	65.94	87.00	74.00	13.88	8.06
5.023	53.06	46.68	19.65	72.71	66.33	87.00	74.00	14.29	7.67
5.050	53.40	46.98	19.65	73.05	66.63	87.00	74.00	13.95	7.37
5.615	51.70	41.84	19.67	71.37	61.51	87.00	74.00	15.63	12.49
5.618	52.79	45.18	19.67	72.46	64.85	87.00	74.00	14.54	9.15

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_1000 M) / Recording (PoE) mode

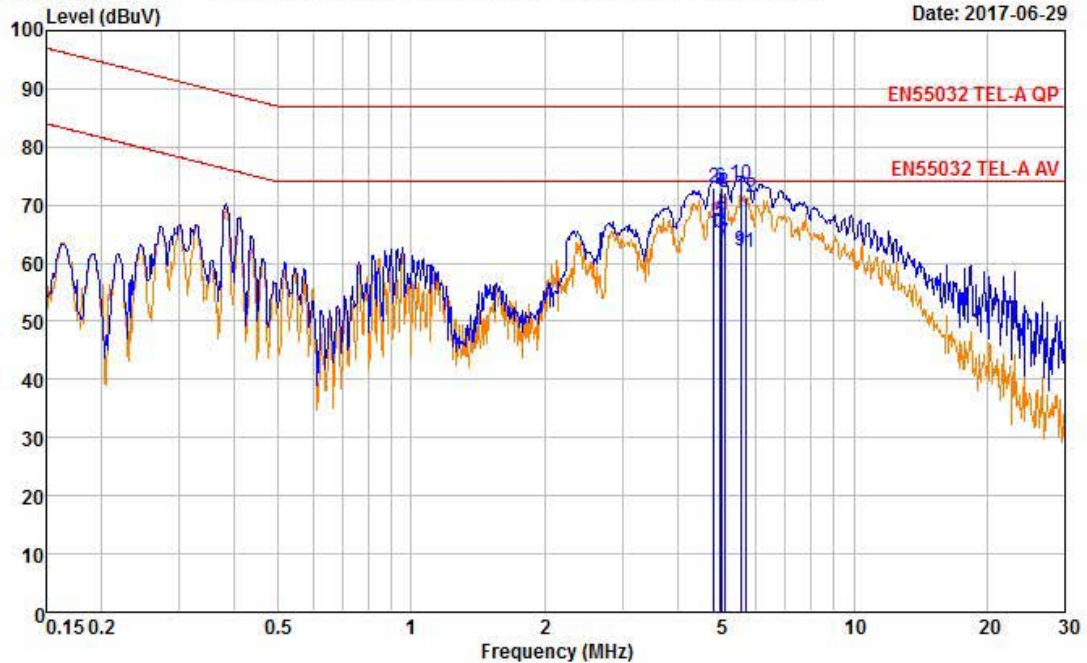
4, Songjuro 236 Beon-gil, Yangji-myeon
Cheoin-gu, Youngin-si, Gyeonggi-do
449-822 Korea
Tel:+82-31-3236008,9
Fax:+82-31-3236010

EUT / Model No. : XNO-6085R* (*N:NT/P:PAL)	Phase : TEL_1000M
Test Mode : Recording mode	Test Power : 230 / 50
Temp. / Humi. : 21 / 45	Test Engineer : LEE H W

Data: 2971

File: D:\Conducted Data\2017\LTA_Conduction_2017_06.EM6 (3043)

Date: 2017-06-29



Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
4.834	53.86	45.86	19.24	73.10	65.10	87.00	74.00	13.90	8.90
4.994	52.93	45.93	19.25	72.18	65.18	87.00	74.00	14.82	8.82
5.024	53.87	47.96	19.24	73.11	67.20	87.00	74.00	13.89	6.80
5.099	52.87	44.27	19.24	72.11	63.51	87.00	74.00	14.89	10.49
5.551	54.32	42.97	19.26	73.58	62.23	87.00	74.00	13.42	11.77
5.698	52.09	42.66	19.27	71.36	61.93	87.00	74.00	15.64	12.07

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

3.2.2 Radiated Emission

Definition:

The test assesses the ability of ancillary equipment to limit their internal noise from being radiated from the enclosure.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 55032:2012/AC:2013
Measuring Distance	: 10m
Measurement Frequency range	: 30 MHz – 1 000 MHz
Measurement RBW	: 120 kHz
Test mode	: Recording (AC, DC, PoE) mode
Result	: Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)
- No other emissions were detected at a level greater than 20 dB below limit

A sample calculation:

COR. F (correction factor)= Antenna factor + Cable loss- Amp.gain- Distance correction

Emission Level= meter reading + COR.F

TEST EQUIPMENT USED: 13, 14, 15, 19, 21, 23

Limit of 10 m for below 1 GHz

CLASS A

Frequency Range	Quasi-peak
(30 – 230) MHz	40 dBuV/m
(230 – 1 000) MHz	47 dBuV/m

CLASS B

Frequency Range	Quasi-peak
(30 – 230) MHz	30 dBuV/m
(230 – 1 000) MHz	37 dBuV/m

Limit of 3m for above 1 GHz

CLASS A

Frequency Range	Average Limit @ 3m (dBμV/m)	Peak limit @ 3m (dBμV/m)
(1 000 – 3 000) MHz	56	76
(3 000 – 6 000) MHz	60	80
NOTE:	The lower limit applies at the transition frequency.	

CLASS B

Frequency Range	Average Limit @ 3m (dBμV/m)	Peak limit @ 3m (dBμV/m)
(1 000 – 3 000) MHz	50	70
(3 000 – 6 000) MHz	54	74
NOTE:	The lower limit applies at the transition frequency.	

TEST EQUIPMENT USED: [13](#), [14](#), [15](#), [19](#), [21](#), [23](#)

Radiated Emission (Below 1 GHz) / Recording (AC) mode _ V



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EUT/Model No.: XNO-6085R* (*N:NT/P:PAL)

Temp/Humi: 21 / 51

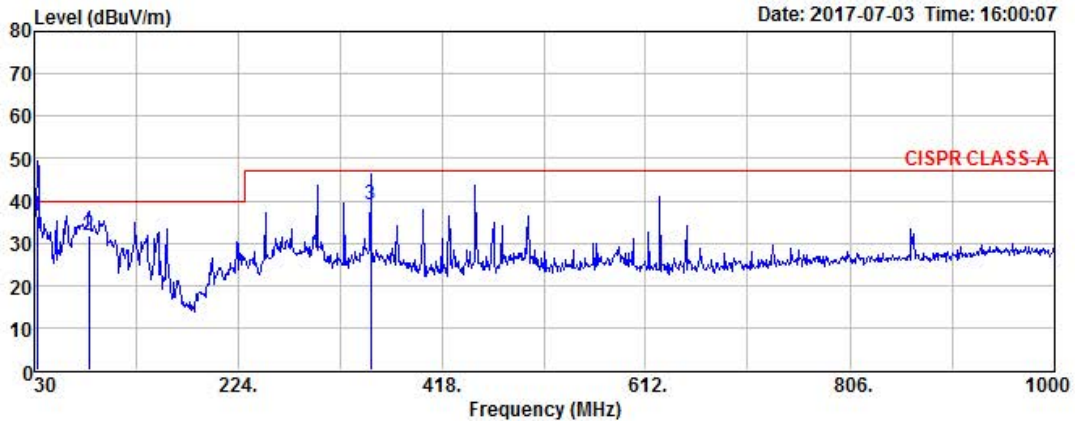
Test Mode : Recording mode

Tested by: LEE H W

Data: 1062

File: C:\Program Files (x86)\e3\1706-1.EM6 (1078)

Date: 2017-07-03 Time: 16:00:07



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
32.91	51.23	-14.90	36.33	40.00	3.67	112	107	VERTICAL
82.38	49.92	-18.26	31.66	40.00	8.34	206	38	VERTICAL
350.10	48.69	-9.54	39.15	47.00	7.85	193	318	VERTICAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / Recording (AC) mode _ H



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EUT/Model No.: XNO-6085R* (*N:NT/P:PAL)

Temp/Humi: 21 / 51

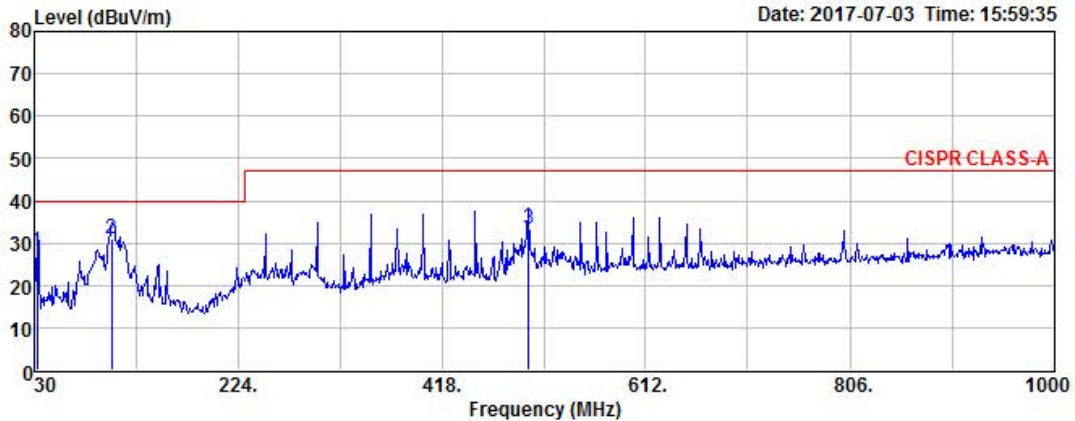
Test Mode : Recording mode

Tested by: LEE H W

Data: 1061

File: C:\Program Files (x86)\e3\1706-1.EM6 (1078)

Date: 2017-07-03 Time: 15:59:35



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
32.91	42.86	-14.90	27.96	40.00	12.04	117	103	HORIZONTAL
103.72	46.49	-15.57	30.92	40.00	9.08	184	83	HORIZONTAL
500.45	40.02	-6.63	33.39	47.00	13.61	193	51	HORIZONTAL

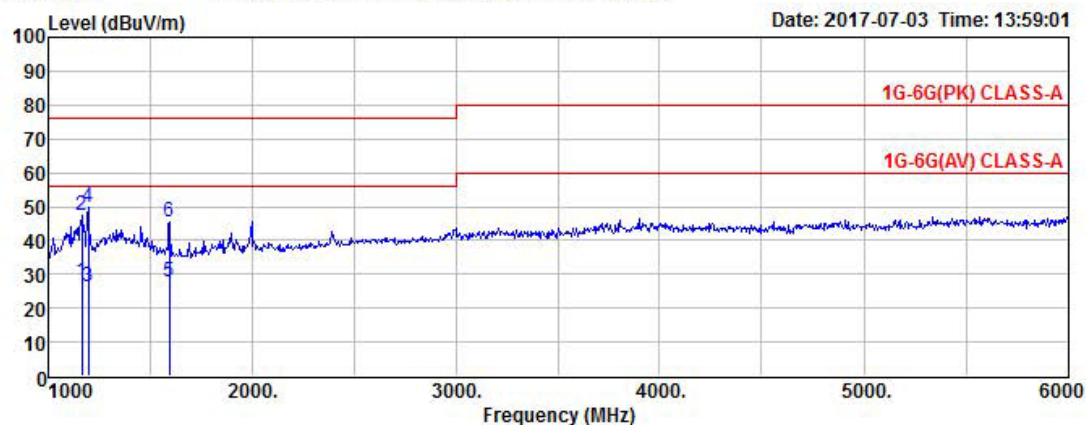
Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Above 1 GHz) / Recording (AC) mode

EUT/Model No.: XNO-6085R* (*N:NT/P:PAL) Temp/Humi: 21 / 51

Test Mode : Recording mode Tested by: LEE H W

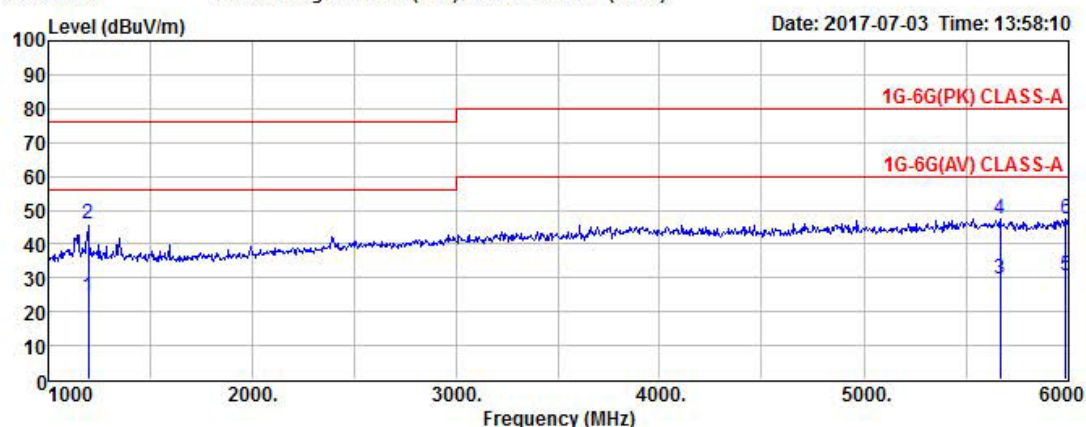
Data: 1032 File: C:\Program Files (x86)\e3\1706-1.EM6 (1042)



EUT/Model No.: XNO-6085R* (*N:NT/P:PAL) Temp/Humi: 21 / 51

Test Mode : Recording mode Tested by: LEE H W

Data: 1031 File: C:\Program Files (x86)\e3\1706-1.EM6 (1042)



Manufacture : Hanwha Techwin Co., Ltd.

Model : XNO-6085R* (*N:NT/P:PAL)

TEST mode : Recording mode

Test Date	Temp.:	Humidity:	Barometric
2017/7/3	[°C]	[%]	[mbar]
	21	51	

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBuV	dBuV	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
1195.0	55.7	34.2	-6.05	49.66	28.15	76.0	56.0	26.34	27.85	113	101	H
5665.0	36.4	18.7	14.52	50.88	33.21	80.0	60.0	25.12	22.79	152	201	H
5985.0	35.3	18.9	15.44	50.71	34.29	80.0	60.0	25.29	21.71	132	27	H
1165.0	56.7	37.0	-5.93	50.74	31.11	76.0	56.0	25.26	24.89	117	105	V
1195.0	59.2	35.9	-6.05	53.12	29.88	76.0	56.0	22.88	26.12	193	304	V
1595.0	52.9	35.5	-4.02	48.88	31.45	76.0	56.0	27.12	24.55	152	20	V

Radiated Emission (Below 1 GHz) / Recording (DC) mode _ V



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EUT/Model No.: XNO-6085R* (*N:NT/P:PAL)

Temp/Humi: 21 / 51

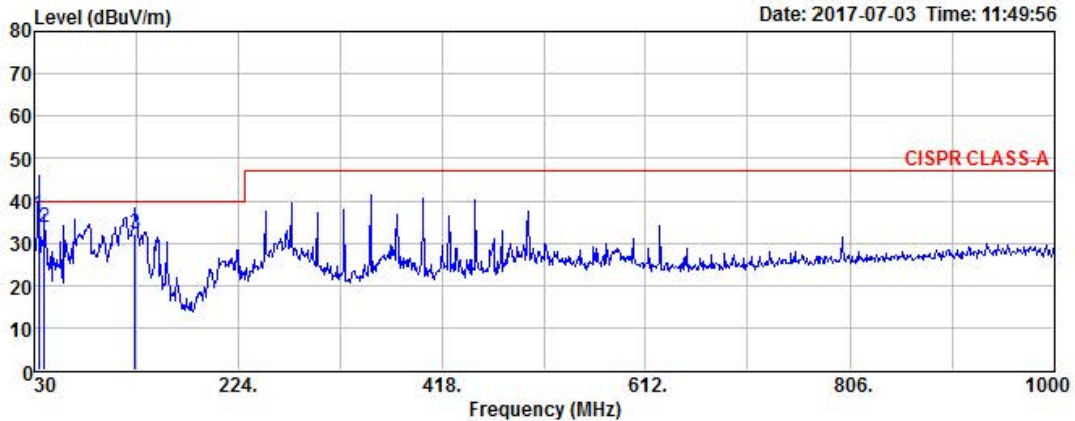
Test Mode : Recording mode

Tested by: LEE H W

Data: 992

File: C:\Program Files (x86)\e3\1706-1.EM6 (1078)

Date: 2017-07-03 Time: 11:49:56



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
33.88	51.61	-14.81	36.80	40.00	3.20	107	183	VERTICAL
39.70	48.07	-14.24	33.83	40.00	6.17	148	81	VERTICAL
126.03	45.32	-13.20	32.12	40.00	7.88	166	207	VERTICAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / Recording (DC) mode _ H



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EUT/Model No.: XNO-6085R* (*N:NT/P:PAL)

Temp/Humi: 21 / 51

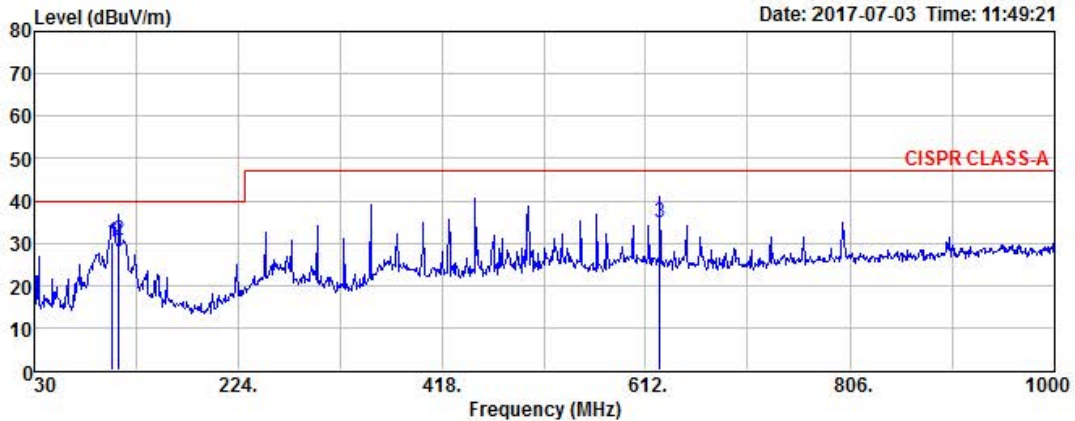
Test Mode : Recording mode

Tested by: LEE H W

Data: 991

File: C:\Program Files (x86)\e3\1706-1.EM6 (1078)

Date: 2017-07-03 Time: 11:49:21



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	dBuV/m	dBuV/m	dB	cm	deg	
104.69	45.46	-15.37	30.09	40.00	9.91	274	151	HORIZONTAL
110.51	45.07	-14.49	30.58	40.00	9.42	138	62	HORIZONTAL
625.58	38.80	-3.80	35.00	47.00	12.00	199	104	HORIZONTAL

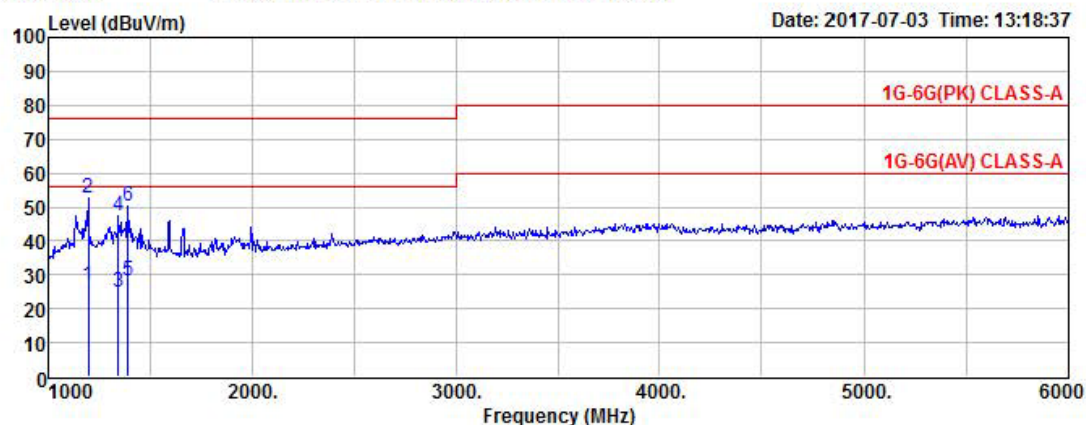
Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Above 1 GHz) / Recording (DC) mode

EUT/Model No.: XNO-6085R* (*N:NT/P:PAL) Temp/Humi: 21 / 51

Test Mode : Recording mode Tested by: LEE H W

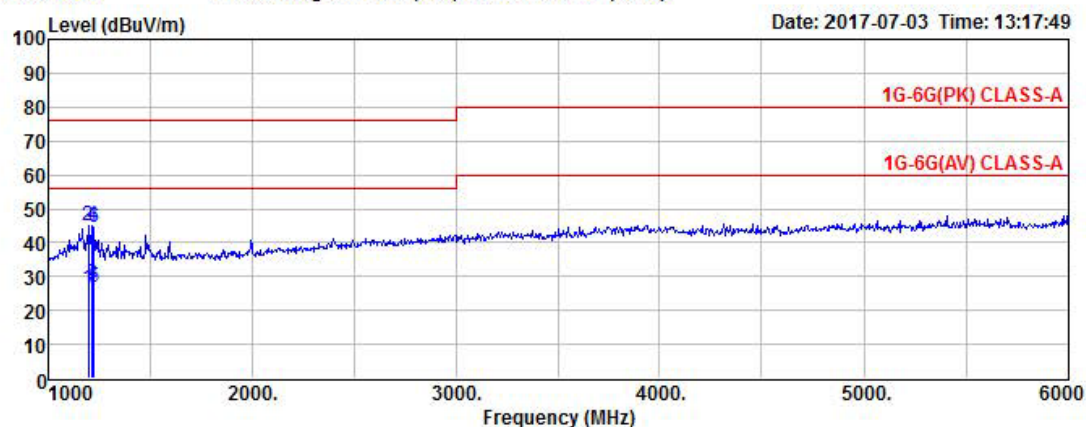
Data: 1012 File: C:\Program Files (x86)\e3\1706-1.EM6 (1042)



EUT/Model No.: XNO-6085R* (*N:NT/P:PAL) Temp/Humi: 21 / 51

Test Mode : Recording mode Tested by: LEE H W

Data: 1011 File: C:\Program Files (x86)\e3\1706-1.EM6 (1042)



Manufacture : Hanwha Techwin Co., Ltd.

Model : XNO-6085R* (*N:NT/P:PAL)

TEST mode : Recording mode

Test Date

2017/7/3

Temp.:
[°C]

21

Humidity:
[%]

51

Barometric
[mbar]

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBuV	dBuV	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
1195.0	54.7	35.7	-6.05	48.68	29.66	76.0	56.0	27.32	26.34	133	182	H
1215.0	54.2	37.3	-5.92	48.30	31.41			27.70	24.59	207	193	H
1225.0	53.8	36.3	-5.82	47.93	30.51			28.07	25.49	116	208	H
1195.0	62.0	36.3	-6.05	55.92	30.29			20.08	25.71	105	155	V
1345.0	56.5	33.7	-5.35	51.11	28.35			24.89	27.65	138	310	V
1390.0	58.6	36.9	-5.1	53.54	31.83			22.46	24.17	152	81	V

Radiated Emission (Below 1 GHz) / Recording (PoE) mode _ V



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EUT/Model No.: XNO-6085R* (*N:NT/P:PAL)

Temp/Humi: 21 / 51

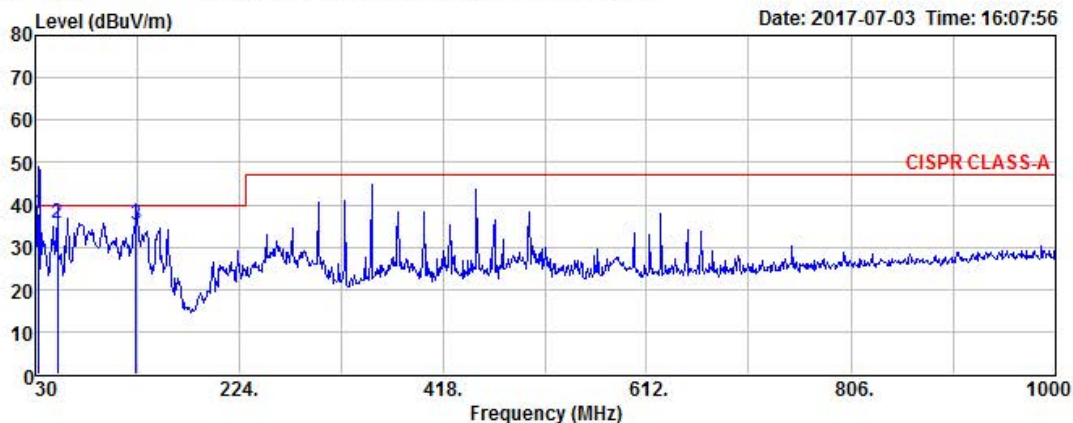
Test Mode : Recording mode

Tested by: LEE H W

Data: 1071

File: C:\Program Files (x86)\e3\1706-1.EM6 (1078)

Date: 2017-07-03 Time: 16:07:56



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
32.91	52.81	-14.90	37.91	40.00	2.09	174	50	VERTICAL
51.34	49.43	-13.83	35.60	40.00	4.40	126	68	VERTICAL
126.03	48.43	-13.20	35.23	40.00	4.77	163	304	VERTICAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / Recording (PoE) mode _ H



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EUT/Model No.: XNO-6085R* (*N:NT/P:PAL)

Temp/Humi: 21 / 51

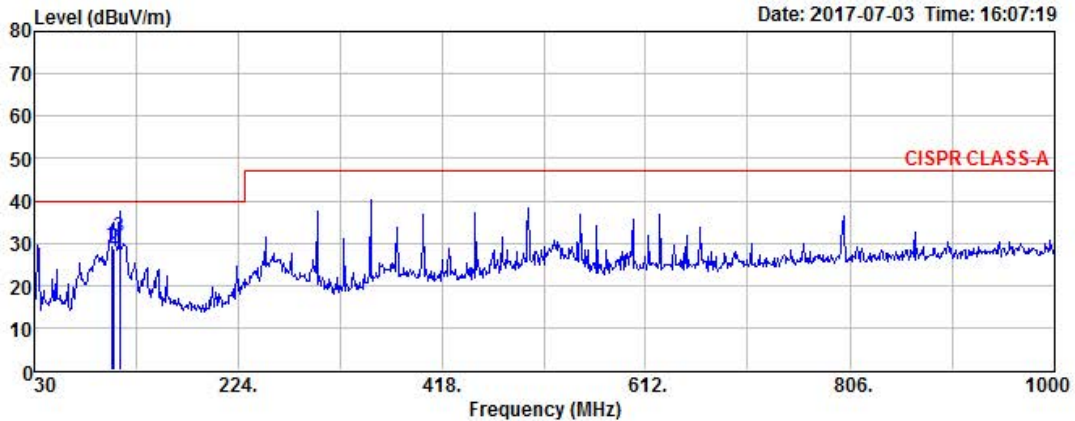
Test Mode : Recording mode

Tested by: LEE H W

Data: 1070

File: C:\Program Files (x86)\e3\1706-1.EM6 (1078)

Date: 2017-07-03 Time: 16:07:19



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
103.72	45.00	-15.57	29.43	40.00	10.57	241	15	HORIZONTAL
105.66	43.98	-15.21	28.77	40.00	11.23	164	183	HORIZONTAL
111.48	45.76	-14.38	31.38	40.00	8.62	311	186	HORIZONTAL

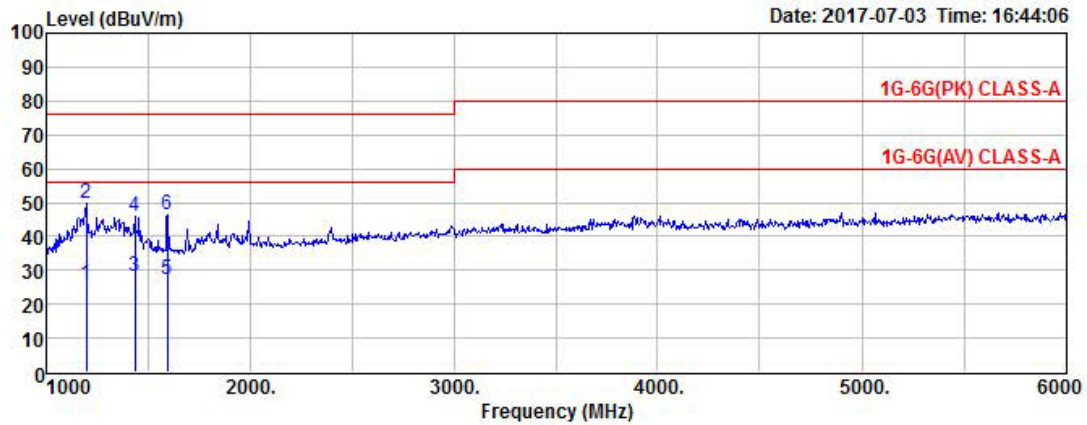
Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Above 1 GHz) / Recording (PoE) mode

EUT/Model No.: XNO-6085R* (*N:NT/P:PAL) Temp/Humi: 21 / 51

Test Mode : Recording mode Tested by: LEE H W

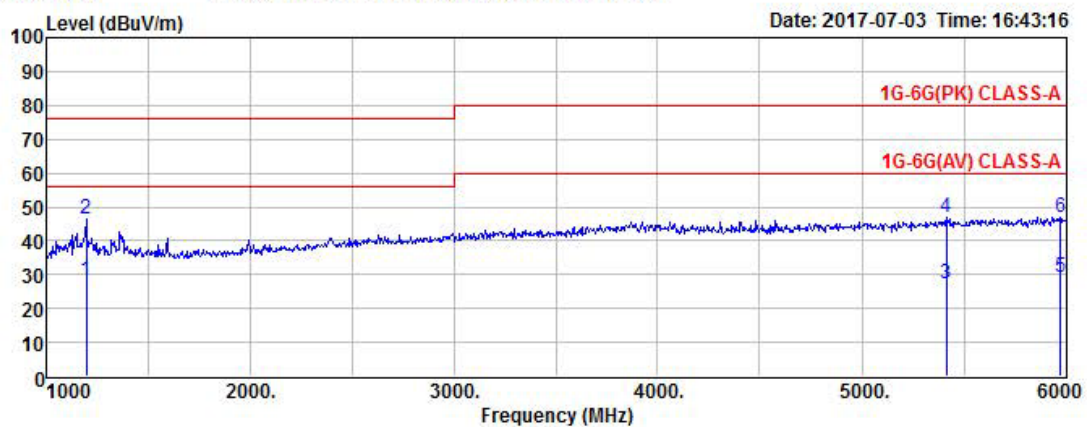
Data: 1092 File: C:\Program Files (x86)\e3\1706-1.EM6 (1100)



EUT/Model No.: XNO-6085R* (*N:NT/P:PAL) Temp/Humi: 21 / 51

Test Mode : Recording mode Tested by: LEE H W

Data: 1091 File: C:\Program Files (x86)\e3\1706-1.EM6 (1100)



Manufacture : Hanwha Techwin Co., Ltd.

Model : XNO-6085R* (*N:NT/P:PAL)

TEST mode : Recording mode

Test Date

2017/7/3

Temp.:
[°C]

21

Humidity:
[%]

51

Barometric
[mbar]

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBuV	dBuV	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
1195.0	56.1	38.0	-6.05	50.03	31.98	76.0	56.0	25.97	24.02	107	157	H
5410.0	36.3	16.4	14.24	50.52	30.61	80.0	60.0	25.48	25.39	102	268	H
5970.0	35.1	17.4	15.38	50.51	32.80	80.0	60.0	25.49	23.20	188	160	H
1195.0	59.4	35.4	-6.05	53.39	29.31	76.0	56.0	22.61	26.69	173	212	V
1435.0	54.1	36.4	-4.79	49.34	31.57	76.0	56.0	26.66	24.43	145	163	V
1595.0	54.0	35.0	-4.02	50.01	30.98	76.0	56.0	25.99	25.02	182	57	V

3.2.3 Harmonic Current (AC power input port)

Definition:

This part deals with the Limitation of harmonic currents injected into the public supply system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-3-2:2014
Test mode	: Recording (AC, DC) mode
Rated power	: 9.63 W
Result	: Complies

Measurement Data:

- Uncertainty(HAR) = +/- 2.24 % (with a 95 % confidence level, k=2)

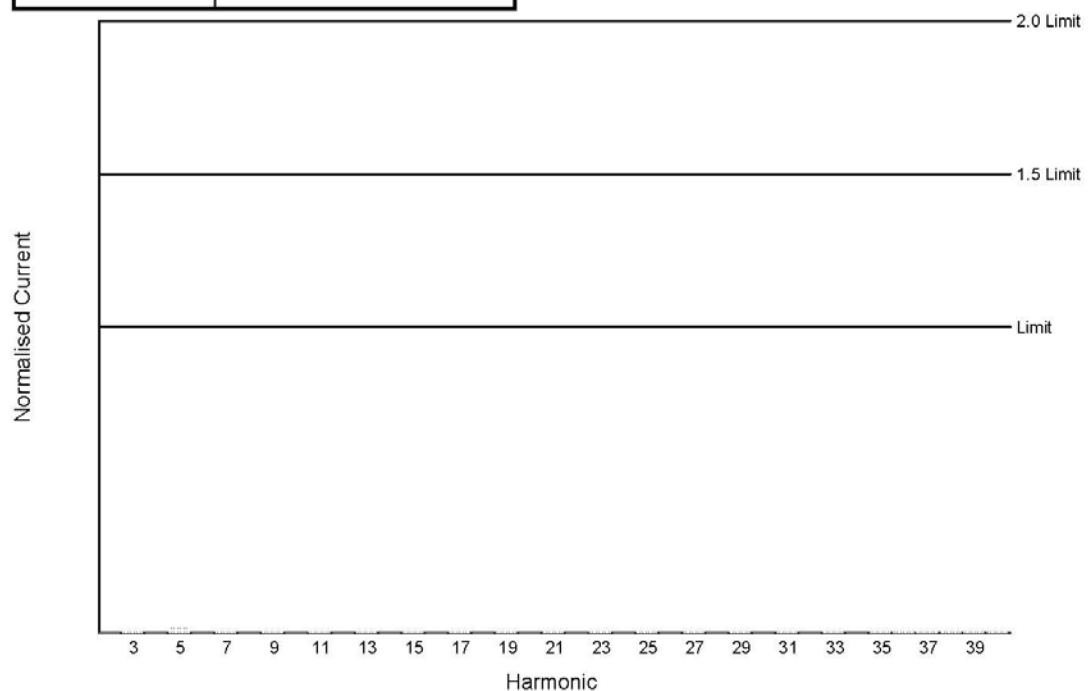
“It has been demonstrated that the HAR generator meets the specified requirements in the standard with at least 95 % confidence.”

Harmonic Current (AC power input port) / Recording (AC) mode

Product: XNO-6085R Serial no: N/A Description: Recording mode Test Date: 2017 Jun 26 4:29pm Result Name: XNO-6085R		2017 Jun 26 4:33pm Page 1 of 1
Type of Test: EN61000:2006 Harmonics inc. interharmonics to EN61000-4-7:2002 Limits: Class A Power Analyzer: Voltech PM6000 SN: 100006700108 Firmware version: v1.22.07RC6 Channel(s): 1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None Shunt(s): 1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None AC Source: Mains / Manual Source		
Harmonic Results Against Chosen Limits: N/A	Notes: Minimum power is greater than maximum	
Test Parameter Details	User Entered	Measured
Operating Frequency:	50	50.0801
Operating Voltage:	230	230.2843
Specified Power:	0.0000	9.6382
Fundamental Current:	0.0000	0.0628
Power Factor:	0.0000	0.5553
Average Input Current:		0.0718
Maximum POHC:		0.0010
POHC Limit:		0.2514
Maximum THC:		0.0283
Minimum Power:	75	
Class Multiplier:	1.0000	
Test Duration:	00:02:30	

Product:	XNO-6085R	2017 Jun 26 4:33pm
Serial no:	N/A	Page 1 of 1
Description:	Recording mode	
Result Name:	XNO-6085R	
Voltech IEC61000-3 Windows Software 1.24.12		Test Date: 2017 Jun 26 4:29pm
Type of Test:	Fluctuating Harmonics Test - Normalised Worst Case Bar Chart (2006)	
Power Analyzer:	Voltech PM6000 SN: 100006700108 Firmware version: v1.22.07RC6	
Channel(s):	1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
Shunt(s):	1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
AC Source:	Mains / Manual Source	
Overall Result:	N/A	

Class	Class A
Class Multiplier	1



Product:	XNO-6085R	2017 Jun 26 4:33pm
Serial no:	N/A	Page 1 of 1
Description:	Recording mode	
Result Name:	XNO-6085R	
Voltech IEC61000-3 Windows Software 1.24.12		Test Date: 2017 Jun 26 4:29pm
Type of Test:	Fluctuating Harmonics Test - Worst Case Table (2006)	
Power Analyzer:	Voltech PM6000 SN: 100006700108 Firmware version: v1.22.07RC6	
Channel(s):	1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
Shunt(s):	1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
AC Source:	Mains / Manual Source	
Overall Result:	N/A	

Class	Class A
Class Multiplier	1

Harm	Limit 1	Limit 2	Average Reading	<L1 <L2	Max Reading	<L2	Pass FAIL	Harm	Limit 1	Limit 2	Average Reading	<L1 <L2	Max Reading	<L2	Pass FAIL
2	1.0800A	1.6200A	0.448mA	N/A	0.492mA	N/A	N/A	3	2.3000A	3.4500A	17.93mA	✓✓	19.24mA	✓	N/A
4	430.0mA	645.0mA	0.215mA	N/A	0.299mA	N/A	N/A	5	1.1400A	1.7100A	18.86mA	✓✓	19.50mA	✓	N/A
6	300.0mA	450.0mA	0.152mA	N/A	0.227mA	N/A	N/A	7	770.0mA	1.1550A	5.872mA	✓✓	5.933mA	✓	N/A
8	230.0mA	345.0mA	0.121mA	N/A	0.181mA	N/A	N/A	9	400.0mA	600.0mA	3.071mA	N/A	3.549mA	N/A	N/A
10	184.0mA	276.0mA	0.114mA	N/A	0.153mA	N/A	N/A	11	330.0mA	495.0mA	1.936mA	N/A	2.125mA	N/A	N/A
12	153.3mA	230.0mA	0.119mA	N/A	0.135mA	N/A	N/A	13	210.0mA	315.0mA	1.593mA	N/A	1.628mA	N/A	N/A
14	131.4mA	197.1mA	0.088mA	N/A	0.119mA	N/A	N/A	15	150.0mA	225.0mA	1.002mA	N/A	1.118mA	N/A	N/A
16	115.0mA	172.5mA	0.092mA	N/A	0.111mA	N/A	N/A	17	132.3mA	198.5mA	0.679mA	N/A	0.783mA	N/A	N/A
18	102.2mA	153.3mA	0.089mA	N/A	0.103mA	N/A	N/A	19	118.4mA	177.6mA	0.686mA	N/A	0.711mA	N/A	N/A
20	92.00mA	138.0mA	0.083mA	N/A	0.093mA	N/A	N/A	21	107.1mA	160.7mA	0.498mA	N/A	0.548mA	N/A	N/A
22	83.63mA	125.4mA	0.081mA	N/A	0.093mA	N/A	N/A	23	97.82mA	146.7mA	0.371mA	N/A	0.444mA	N/A	N/A
24	76.66mA	115.0mA	0.088mA	N/A	0.100mA	N/A	N/A	25	90.00mA	135.0mA	0.380mA	N/A	0.400mA	N/A	N/A
26	70.76mA	106.1mA	0.082mA	N/A	0.098mA	N/A	N/A	27	83.33mA	125.0mA	0.307mA	N/A	0.321mA	N/A	N/A
28	65.71mA	98.57mA	0.080mA	N/A	0.094mA	N/A	N/A	29	77.58mA	116.3mA	0.257mA	N/A	0.292mA	N/A	N/A
30	61.33mA	92.00mA	0.080mA	N/A	0.090mA	N/A	N/A	31	72.58mA	108.8mA	0.249mA	N/A	0.265mA	N/A	N/A
32	57.50mA	86.25mA	0.078mA	N/A	0.087mA	N/A	N/A	33	68.18mA	102.2mA	0.211mA	N/A	0.231mA	N/A	N/A
34	54.11mA	81.17mA	0.079mA	N/A	0.089mA	N/A	N/A	35	64.28mA	96.42mA	0.187mA	N/A	0.211mA	N/A	N/A
36	51.11mA	76.66mA	0.079mA	N/A	0.087mA	N/A	N/A	37	60.81mA	91.21mA	0.188mA	N/A	0.203mA	N/A	N/A
38	48.42mA	72.63mA	0.078mA	N/A	0.091mA	N/A	N/A	39	57.69mA	86.53mA	0.163mA	N/A	0.173mA	N/A	N/A
40	46.00mA	69.00mA	0.077mA	N/A	0.087mA	N/A	N/A								

<L1 : Reading is below limit 1.

<L2 : Reading is below limit 2.

N/A : Overall Result is N/A.

Product:	XNO-6085R	2017 Jun 26 4:33pm
Serial no:	N/A	Page 1 of 1
Description:	Recording mode	
Result Name:	XNO-6085R	
Voltech IEC61000-3 Windows Software 1.24.12		Test Date: 2017 Jun 26 4:29pm
Type of Test:	Fluctuating Harmonics Test - Source Qualification (2006)	
Power Analyzer:	Voltech PM6000 SN: 100006700108 Firmware version: v1.22.07RC6	
Channel(s):	1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
Shunt(s):	1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
AC Source:	Mains / Manual Source	
Overall Result:	N/A	

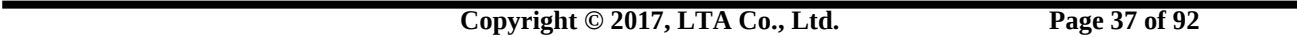
	Nominal	Measured	Deviation	Allowed Deviation	Result
Supply Voltage	230.00V	230.28V	0.28V	4.60V	Pass
Supply Frequency	50.00Hz	50.08Hz	0.08Hz	0.25Hz	Pass
Crest Factor	1.4100	1.4183	0.0083	+/- 0.01	Pass

Harmonic	Reading	Limit	Result	Harmonic	Reading	Limit	Result
2	0.12%	0.20%	Pass	3	0.04%	0.90%	Pass
4	0.02%	0.20%	Pass	5	0.01%	0.40%	Pass
6	0.01%	0.20%	Pass	7	0.02%	0.30%	Pass
8	0.02%	0.20%	Pass	9	0.02%	0.20%	Pass
10	0.01%	0.20%	Pass	11	0.01%	0.10%	Pass
12	0.01%	0.10%	Pass	13	0.01%	0.10%	Pass
14	0.01%	0.10%	Pass	15	0.01%	0.10%	Pass
16	0.01%	0.10%	Pass	17	0.00%	0.10%	Pass
18	0.01%	0.10%	Pass	19	0.00%	0.10%	Pass
20	0.00%	0.10%	Pass	21	0.00%	0.10%	Pass
22	0.00%	0.10%	Pass	23	0.01%	0.10%	Pass
24	0.01%	0.10%	Pass	25	0.01%	0.10%	Pass
26	0.00%	0.10%	Pass	27	0.01%	0.10%	Pass
28	0.00%	0.10%	Pass	29	0.00%	0.10%	Pass
30	0.00%	0.10%	Pass	31	0.01%	0.10%	Pass
32	0.01%	0.10%	Pass	33	0.01%	0.10%	Pass
34	0.01%	0.10%	Pass	35	0.00%	0.10%	Pass
36	0.00%	0.10%	Pass	37	0.00%	0.10%	Pass
38	0.01%	0.10%	Pass	39	0.00%	0.10%	Pass
40	0.01%	0.10%	Pass				

Harmonic Current (AC power input port) / Recording (DC) mode

Product: XNO-6085R Serial no: N/A Description: Recording mode Test Date: 2017 Jun 26 4:06pm Result Name: XNO-6085R_PASS		2017 Jun 26 4:10pm Page 1 of 1
Type of Test: EN61000:2006 Harmonics inc. interharmonics to EN61000-4-7:2002 Limits: Class A Power Analyzer: Voltech PM6000 SN: 100006700108 Firmware version: v1.22.07RC6 Channel(s): 1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None Shunt(s): 1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None AC Source: Mains / Manual Source		
Harmonic Results Against Chosen Limits: N/A	Notes: Minimum power is greater than maximum	
Test Parameter Details Operating Frequency: Operating Voltage: Specified Power: Fundamental Current: Power Factor: Average Input Current: Maximum POHC: POHC Limit: Maximum THC: Minimum Power: Class Multiplier: Test Duration:	User Entered 50 230 0.0000 0.0000 0.0000 75 1.0000 00:02:30	Measured 49.9840 230.2972 5.8166 0.0306 0.3094 0.0815 0.0314 0.2514 0.0710

Class	Class A
Class Multiplier	1



Product:	XNO-6085R	2017 Jun 26 4:10pm
Serial no:	N/A	Page 1 of 1
Description:	Recording mode	
Result Name:	XNO-6085R_PASS	
Voltech IEC61000-3 Windows Software 1.24.12		Test Date: 2017 Jun 26 4:06pm
Type of Test:	Fluctuating Harmonics Test - Worst Case Table (2006)	
Power Analyzer:	Voltech PM6000 SN: 100006700108 Firmware version: v1.22.07RC6	
Channel(s):	1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
Shunt(s):	1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
AC Source:	Mains / Manual Source	
Overall Result:	N/A	

Class	Class A
Class Multiplier	1

Harm	Limit 1	Limit 2	Average Reading	<L1 <L2	Max Reading	<L2	Pass FAIL	Harm	Limit 1	Limit 2	Average Reading	<L1 <L2	Max Reading	<L2	Pass FAIL
2	1.0800A	1.6200A	1.919mA	N/A	2.028mA	N/A	N/A	3	2.3000A	3.4500A	23.84mA	✓✓	23.94mA	✓	N/A
4	430.0mA	645.0mA	1.902mA	N/A	2.006mA	N/A	N/A	5	1.1400A	1.7100A	23.50mA	✓✓	23.61mA	✓	N/A
6	300.0mA	450.0mA	1.909mA	N/A	2.005mA	N/A	N/A	7	770.0mA	1.1550A	22.95mA	✓✓	23.05mA	✓	N/A
8	230.0mA	345.0mA	1.904mA	N/A	1.995mA	N/A	N/A	9	400.0mA	600.0mA	22.21mA	✓✓	22.32mA	✓	N/A
10	184.0mA	276.0mA	1.894mA	N/A	1.984mA	N/A	N/A	11	330.0mA	495.0mA	21.32mA	✓✓	21.43mA	✓	N/A
12	153.3mA	230.0mA	1.880mA	N/A	1.970mA	N/A	N/A	13	210.0mA	315.0mA	20.30mA	✓✓	20.39mA	✓	N/A
14	131.4mA	197.1mA	1.862mA	N/A	1.946mA	N/A	N/A	15	150.0mA	225.0mA	19.14mA	✓✓	19.24mA	✓	N/A
16	115.0mA	172.5mA	1.831mA	N/A	1.918mA	N/A	N/A	17	132.3mA	198.5mA	17.90mA	✓✓	17.99mA	✓	N/A
18	102.2mA	153.3mA	1.797mA	N/A	1.895mA	N/A	N/A	19	118.4mA	177.6mA	16.55mA	✓✓	16.63mA	✓	N/A
20	92.00mA	138.0mA	1.757mA	N/A	1.864mA	N/A	N/A	21	107.1mA	160.7mA	15.17mA	✓✓	15.26mA	✓	N/A
22	83.63mA	125.4mA	1.708mA	N/A	1.827mA	N/A	N/A	23	97.82mA	146.7mA	13.76mA	✓✓	13.84mA	✓	N/A
24	76.66mA	115.0mA	1.654mA	N/A	1.770mA	N/A	N/A	25	90.00mA	135.0mA	12.31mA	✓✓	12.39mA	✓	N/A
26	70.76mA	106.1mA	1.592mA	N/A	1.705mA	N/A	N/A	27	83.33mA	125.0mA	10.88mA	✓✓	10.97mA	✓	N/A
28	65.71mA	98.57mA	1.530mA	N/A	1.638mA	N/A	N/A	29	77.58mA	116.3mA	9.517mA	✓✓	9.611mA	✓	N/A
30	61.33mA	92.00mA	1.464mA	N/A	1.570mA	N/A	N/A	31	72.58mA	108.8mA	8.201mA	✓✓	8.297mA	✓	N/A
32	57.50mA	86.25mA	1.399mA	N/A	1.505mA	N/A	N/A	33	68.18mA	102.2mA	6.960mA	✓✓	7.051mA	✓	N/A
34	54.11mA	81.17mA	1.335mA	N/A	1.444mA	N/A	N/A	35	64.28mA	96.42mA	5.829mA	✓✓	5.922mA	✓	N/A
36	51.11mA	76.66mA	1.289mA	N/A	1.399mA	N/A	N/A	37	60.81mA	91.21mA	4.837mA	N/A	4.935mA	N/A	N/A
38	48.42mA	72.63mA	1.228mA	N/A	1.350mA	N/A	N/A	39	57.69mA	86.53mA	3.995mA	N/A	4.091mA	N/A	N/A
40	46.00mA	69.00mA	1.190mA	N/A	1.302mA	N/A	N/A								

<L1 : Reading is below limit 1.

<L2 : Reading is below limit 2.

N/A : Overall Result is N/A.

Product:	XNO-6085R	2017 Jun 26 4:10pm
Serial no:	N/A	Page 1 of 1
Description:	Recording mode	
Result Name:	XNO-6085R_PASS	
Voltech IEC61000-3 Windows Software 1.24.12		Test Date: 2017 Jun 26 4:06pm
Type of Test:	Fluctuating Harmonics Test - Source Qualification (2006)	
Power Analyzer:	Voltech PM6000 SN: 100006700108 Firmware version: v1.22.07RC6	
Channel(s):	1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
Shunt(s):	1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None	
AC Source:	Mains / Manual Source	
Overall Result:	N/A	

	Nominal	Measured	Deviation	Allowed Deviation	Result
Supply Voltage	230.00V	230.30V	0.30V	4.60V	Pass
Supply Frequency	50.00Hz	49.98Hz	0.02Hz	0.25Hz	Pass
Crest Factor	1.4100	1.4179	0.0079	+/- 0.01	Pass

Harmonic	Reading	Limit	Result	Harmonic	Reading	Limit	Result
2	0.08%	0.20%	Pass	3	0.03%	0.90%	Pass
4	0.02%	0.20%	Pass	5	0.01%	0.40%	Pass
6	0.01%	0.20%	Pass	7	0.02%	0.30%	Pass
8	0.02%	0.20%	Pass	9	0.02%	0.20%	Pass
10	0.01%	0.20%	Pass	11	0.01%	0.10%	Pass
12	0.01%	0.10%	Pass	13	0.01%	0.10%	Pass
14	0.01%	0.10%	Pass	15	0.01%	0.10%	Pass
16	0.01%	0.10%	Pass	17	0.01%	0.10%	Pass
18	0.01%	0.10%	Pass	19	0.01%	0.10%	Pass
20	0.01%	0.10%	Pass	21	0.00%	0.10%	Pass
22	0.00%	0.10%	Pass	23	0.01%	0.10%	Pass
24	0.01%	0.10%	Pass	25	0.01%	0.10%	Pass
26	0.00%	0.10%	Pass	27	0.00%	0.10%	Pass
28	0.00%	0.10%	Pass	29	0.01%	0.10%	Pass
30	0.00%	0.10%	Pass	31	0.01%	0.10%	Pass
32	0.01%	0.10%	Pass	33	0.00%	0.10%	Pass
34	0.01%	0.10%	Pass	35	0.00%	0.10%	Pass
36	0.00%	0.10%	Pass	37	0.00%	0.10%	Pass
38	0.01%	0.10%	Pass	39	0.00%	0.10%	Pass
40	0.00%	0.10%	Pass				

3.2.4 Voltage Variation and Flicking (AC power input port)

Definition:

This section is concerned with the limitation of voltage fluctuations and flicker impressed on the public low-voltage system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method : EN 61000-3-3:2013

Test mode : 9.63 W

Result : **Complies**

Measurement Data:

- Uncertainty(FLK) = +/- 9.94 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the FLK generator meets the specified requirements in the standard with at least 95 % confidence.”

TEST EQUIPMENT USED: 25, 26

Voltage Variation and Flicking (AC power input port) / Recording (AC) mode

Product:	XNO-6085R			2017 Jun 26 4:45pm
Serial no:	N/A			Page 1 of 1
Description:	Recording mode			
Result Name:	XNO-6085_PASS			
Voltech IEC61000-3 Windows Software 1.24.12			Test Date: 2017 Jun 26 4:34pm	
Type of Test:	Flickermeter Test - Table			
Power Analyzer:	Voltech PM6000 SN: 100006700108 Firmware Version: v1.22.07RC6			
Channel(s):	1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None			
Shunt(s):	1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None			
AC Source:	Mains / Manual Source			
Overall Result:	Notes: Measurement method - Voltage Source frequency lower than nominal			
PASS				

	Pst	dc (%)	dmax (%)	d(t) > 3.3%(ms)
Limit	1.000	3.300	4.000	500
Reading 1	0.071	0.000	0.000	0

Voltage Variation and Flicking (AC power input port) / Recording (DC) mode

Product:	XNO-6085R			2017 Jun 26 4:23pm
Serial no:	N/A			Page 1 of 1
Description:	Recording mode			
Result Name:	XNO-6085R			
Voltech IEC61000-3 Windows Software 1.24.12			Test Date: 2017 Jun 26 4:11pm	
Type of Test:	Flickermeter Test - Table			
Power Analyzer:	Voltech PM6000 SN: 100006700108 Firmware Version: v1.22.07RC6			
Channel(s):	1. SN: 090015500547, 21 Adjusted Date: 7 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None			
Shunt(s):	1. SN: 091024300314, 4 Adjusted Date: 6 FEB 2007. 2. SN:None Adjusted Date:None 3. SN:None Adjusted Date:None 4. SN:None Adjusted Date:None 5. SN:None Adjusted Date:None 6. SN:None Adjusted Date:None			
AC Source:	Mains / Manual Source			
Overall Result:	Notes: Measurement method - Voltage Source frequency lower than nominal			
PASS				

	Pst	dc (%)	dmax (%)	d(t) > 3.3%(ms)
Limit	1.000	3.300	4.000	500
Reading 1	0.071	0.000	0.000	0

3.3 IMMUNITY

3.3.1 Electrostatic Discharge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of an electrostatic discharge.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-2 :2009
Temperature / Humidity / Pressure	:	21 °C / 43 %RH / 100.1 kPa
Discharge Impedance	:	(330 ±10%)Ω / (150 ±10%) pF
Type of Discharge (air discharge)	:	± 2kV, ± 4 kV, ± 8 kV
Type of Discharge (contact discharge)	:	± 6 kV
Number of discharges at each point	:	10 of each polarity
Discharge Repetition on Rate	:	1 / sec
Test mode	:	Recording (AC, DC, PoE) mode
Result	:	Complies

Measurement Data:

- Uncertainty(ESD) = +/- 5 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the ESD generator meets the specified requirements in the standard with at least 95 % confidence.”

- Refer to the next page

Criteria for compliance:

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

1-2. Indirect Discharge

No.	Position	Kind of Discharge	Results	Remarks
①	HCP	Contact	Complies	No reaction recognized
②	VCP	Contact	Complies	No reaction recognized

1-2. Direct Discharge

No.	Position	Kind of Discharge	Result	Remarks
1	Enclosure	Contact	Complies	No reaction recognized
2	AC IN/DC IN	Air	Complies	No reaction recognized
3	Lens	Air	Complies	No reaction recognized
4	Network	Air	Complies	No reaction recognized
5	Audio OUT	Air	Complies	No reaction recognized
6	Audio IN	Air	Complies	No reaction recognized
7	Micro USB	Air	Complies	No reaction recognized
8	Video	Air	Complies	No reaction recognized
9	ALARM	Air	Complies	No reaction recognized
10	GND	Air	Complies	No reaction recognized
11	Micro SD Slot	Air	Complies	No reaction recognized

TEST EQUIPMENT USED: 27, 28, 03

3.3.2 RF Electromagnetic Field

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic field disturbance.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-3:2006/A2:2010
Frequency range	: 80 MHz to 2700 MHz
Test level	: 10 V/m (measured unmodulated)
Amplitude Modulation	: AM, 80 %, 1 kHz Sinusoidal PM, 1 Hz (0.5s ON : 0.5s OFF)
Step size	: 1 % of fundamental
Dwell Time	: 3 s
Test mode	: Recording (AC, DC, PoE) mode
Result	: Complies

Measurement Data:

- Uncertainty = +/- 1.6dB (with a 95 % confidence level, k=2.28)

“It has been demonstrated that the RS generator meets the specified requirements in the standard with at least 95 % confidence.”

Port	Test level (V/m)	Result		Remark
		Horizontal	Vertical	
Enclosure	10	Complies	Complies	No reaction recognized

Criteria for compliance:

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.
- For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m.
 - a) There is no permanent damage or change to the EUT.
 - b) At 3 V/m, any deterioration of the picture is so minor that the system could still be used.
 - c) There is no observable deterioration of the picture at 1 V/m

TEST EQUIPMENT USED: 29, 30, 31, 32, 33, 34, 35, 03, 28

3.3.3 Electrical fast transients

Definition:

The test assesses the ability of the EUT to operate as intended in the event of fast transients presence on one of the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-4-4:2012
Cable length	:	< 3 m
Test level	:	2.0 kV (AC power input port) 1.0 kV (Signal port)
Polarity	:	Negative/ positive
Repetition frequency	:	100 kHz
Test mode	:	Recording (AC, DC, PoE) mode
Result	:	Complies

Measurement Data:

- Uncertainty = +/- 10 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the EFT/Burst generator meets the specified requirements in the standard with at least 95 % confidence.”

- Refer to the next page

Criteria for compliance:

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

power Line	Test level	Result	Remarks
L – N – PE	+ 2 kV	Complies	No reaction recognized
	- 2 kV	Complies	No reaction recognized

Signal Line	Test level	Result	Remarks
LAN	+ 1 kV	Complies	No reaction recognized
	- 1 kV	Complies	No reaction recognized

TEST EQUIPMENT USED: 57, 28, 15, 58, 59

3.3.4 Surge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of surge presence on the AC main power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-5:2014
Test level	: ± 0.5 kV, ± 1 kV (line to line) ± 0.5 kV, ± 1 kV, ± 2 kV (line to ground), ± 0.5 kV, ± 1 kV (signal line)
Polarity	: Negative/ positive
Wave shape	: 1.2/ 50 μ s pulse
Number of surges	: 5 (at each phase)
Test mode	Recording (AC, DC, PoE) mode
Result	: Complies

Measurement Data:

- Uncertainty = +/- 10 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the Surge generator meets the specified requirements in the standard with at least 95 % confidence.”

- Refer to the next page

Criteria for compliance:

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

TEST EQUIPMENT USED: 57, 28, 15, 58

Measurement Data:

Phase	Line	level	Result	Phase	Line	level	Result
0°	Line(L) to line(N)	+1 kV	Complies	90°	Line(L) to line(N)	+1 kV	Complies
		-1 kV	Complies			-1 kV	Complies
	Line(L) to ground(PE)	+2 kV	Complies		Line(L) to ground(PE)	+2 kV	Complies
		-2 kV	Complies			-2 kV	Complies
	Line(N) to ground(PE)	+2 kV	Complies		Line(N) to ground(PE)	+2 kV	Complies
		-2 kV	Complies			-2 kV	Complies
180°	Line(L) to line(N)	+1 kV	Complies	270°	Line(L) to line(N)	+1 kV	Complies
		-1 kV	Complies			-1 kV	Complies
	Line(L) to ground(PE)	+2 kV	Complies		Line(L) to ground(PE)	+2 kV	Complies
		-2 kV	Complies			-2 kV	Complies
	Line(N) to ground(PE)	+2 kV	Complies		Line(N) to ground(PE)	+2 kV	Complies
		-2 kV	Complies			-2 kV	Complies

Phase	Line	level	Result
-	-	-	-
		-	-

TEST EQUIPMENT USED: 57, 28, 15, 58

3.3.5 Conducted disturbances, induced by radio-frequency fields

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic disturbance on the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-6:2014
Frequency range	: 0.15MHz – 100 MHz
Test level	: 10 Vrms unmodulated
Amplitude Modulation	: AM, 80 %, 1 kHz Sinusoidal
Step size	: 1 % of fundamental.
Test mode	: Recording (AC, DC, PoE) mode
Result	: Complies

Measurement Data:

- Uncertainty = +/-1.25 dB (with a 95 % confidence level, k=2)

Port	Test level (Vrms)	Result	Remarks
Power Line	10	Complies	No reaction recognized

Port	Test level (Vrms)	Result	Remarks
LAN	10	Complies	No reaction recognized

Criteria for compliance:

- There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at $U_0 = 130$ dBuV.
- For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at $U_0 = 140$ dBuV.
 - a) There is no permanent damage or change to the EUT.
 - b) At $U_0 = 130$ dBuV, any deterioration of the picture is so minor that the system could still be used.
 - c) There is no observable deterioration of the picture at $U_0 = 120$ dBuV

TEST EQUIPMENT USED: 46, 47, 48, 03, 28, 49, 51, 52

3.3.6 Mains supply voltage dips, short interruptions

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage dips and interruptions present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-11:2004
Ut	: 230 Vac
Test mode	: Recording (AC, DC, PoE) mode
Result	: Complies

Measurement Data:

- Uncertainty = +/- 5 % (with a 95 % confidence level, k=2)

“It has been demonstrated that the Voltage dips generator meets the specified requirements in the standard with at least 95 % confidence.”

Test Level %Ut	Voltage droop and interruptions %Ut	Duration of Reduction (period)	Result	Remarks
80	20	250	Complies	No reaction recognized
70	30	25	Complies	No reaction recognized
40	60	10	Complies	No reaction recognized
0	100	250	Complies	EUT took off during the test. After the test, EUT operated normally.

Criteria for compliance:
- Mains supply voltage variations

There shall be no damage, malfunction or change of status due to the different supply voltage conditions.

- Mains supply voltage dips and short interruptions

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

During the 250 period power loss, in accordance with the standard, a UPS was used to maintain full operation of the unit.

TEST EQUIPMENT USED: 57, 28, 15, 57

3.3.7 Mains supply voltage variations

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage variations present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 50130-4 Clause 7
Supply Voltage maximum	: $U_{nom} + 10\%$
Supply Voltage minimum	: $U_{nom} - 15\%$
Ut	: 230 Vac
Test mode	: Recording (AC, DC, PoE) mode
Result	: Complies

Measurement Data:

U_{nom} = Nominal mains voltage. Where provision is made to adapt the equipment to suit a number of nominal supply voltages (e.g. by transformer tap changing), the above conditioning severity shall be applied for each nominal voltage, with the equipment suitably adapted. For equipment which is claimed to be suitable for a range of nominal mains voltages (e.g. 220/240 V) without adaptation, $U_{max} = (\text{Maximum } U_{nom}) + 10\%$, and $U_{min} = (\text{Minimum } U_{nom}) - 15\%$. In any case the range of U_{nom} must include the European nominal mains voltage of 230 V.

2 Mains supply voltage variations

230 V, 50 Hz

Test LevelCondition		Test Level (V)	Result	Remarks
U_{nom}	+10%	253	Complies	No reaction recognized
U_{nom}	-15%	195.5	Complies	No reaction recognized

TEST EQUIPMENT USED: [57](#), [28](#), [15](#), [58](#)

APPENDIX A

TEST EQUIPMENT AND ANCILLARIES USED FOR TESTS

To facilitate inclusion on each page of the test equipment used for related tests, each item of test equipment are identified by the Test Laboratory.

	Description	Model No.	Serial No.	Manufacturer	Interval	LAST Cal.
1	EMI TEST Receiver	ESR	101499	Rohde & Schwarz	1 year	Jul-16
2	Pulse Limiter	ESH3-Z2	100710	Rohde & Schwarz	1 year	Mar-17
3	DIGITAL THERMO HYGROMETER	TH-611	NONE	BODYCOM	1 year	Sep-16
4	DTV Signal Generator	MFG-100	15M2002	MFLO	1 year	Mar-17
5	Color TV Pattern Generator	PM-5518-TX	LO5333	Philips	-	-
6	LISN	ESH3-Z6	100378	Rohde & Schwarz	1 year	Sep-16
7	LISN(main)	ESH3-Z5	893045/017	Rohde & Schwarz	1 year	Mar-17
8	LISN(sub)	ENV216	100408	Rohde & Schwarz	1 year	Sep-16
9	ISN	ISN T800	27109	TESEQ	1 year	Jan-17
10	ISN	ENY81-CA6	101565	Rohde & Schwarz	1 year	Jan-17
11	CURRENT PROBE	EZ-17	100508	Rohde & Schwarz	1 year	Jan-17
12	LISN	ESH3-Z6	100378	Rohde & Schwarz	1 year	Sep-16
13	EMI TEST Receiver	ESC17	100772	Rohde & Schwarz	1 year	Sep-16
14	Amplifier (25 dB)	8447D	2944A07974	HP	1 year	Sep-16
15	DIGITAL THERMO HYGROMETER	TESTEK-303A	TAEGUANG	-	1 year	Mar-17
16	STEP TRANSFORMER	INA6502	34270	SCHAFFNER	1 year	Sep-16
17	Log.-Per. Antenna	VULP 9118	9118 A 401	SCHWARZBECK	2 year	Apr-17
18	Biconical Antenna	VHA 9103	VHA 9103-2315	SCHWARZBECK	2 year	Apr-17
19	TRILOG Antenna	VULB9160	9160-3237	SCHWARZBECK	2 year	May-17
20	TRILOG Antenna	VULB9160	9160-3237	SCHWARZBECK	2 year	Apr-17
21	Amplifier (25 dB)	8449B	3008A00337	HP	1 year	Mar-17
22	Spectrum Analyzer (~ 26.5 GHz)	E4407B	MY45108946	Agilent	1 year	Mar-17
23	HORN ANTENNA	3115	55005	ETS	2 year	May-17
24	HORN ANTENNA	3115	55005	ETS	2 year	Apr-17
25	Universal Power Analyzer	PM6000	1.00007E+11	Voltech Instruments	1 year	Mar-17
26	Reference Impedance Network	ES4152	9074424	NF Corp.	1 year	Sep-16
27	ESD Slimulator	ESS-2000	ESS0625187	NOISEKEN	1 year	Apr-17
28	Hygro-Thermograph	THB-36	0041557-01	ISUZU	1 year	Dec-16
29	Signal Generator	E4432B	MY41310632	Agilent	1 year	May-17
30	Power Meter	E4419B	GB38410133	Agilent	1 year	Jun-17
31	RF POWER AMPLIFIER	ITA0300KL-300	0300KL 1507 001	INFINITECH	1 year	Aug-16
32	RF POWER AMPLIFIER	ITA2000KL-120	200KL 1507 001	INFINITECH	1 year	Aug-16
33	RF POWER AMPLIFIER	ITA4500KL-70	4500KL 1507 001	INFINITECH	1 year	Aug-16
34	RF POWER AMPLIFIER	ITA0750KL-300	0750KL 1507 001	INFINITECH	1 year	Aug-16
35	Log.-Per.Antenna (80 MHz ~ 3 GHz)	K9128	NONE	RAPA	-	-
36	Microphone	MP201	530147	BSWA	1 year	Nov-16
37	Sound Acoustic Tester	TST-1000	15065-A	TESTEK	1 year	Nov-16

	Description	Model No.	Serial No.	Manufacturer	Interval	LAST Cal.
38	Horn Antenna	3115A	114105	ETS	2 year	Jul-16
39	Signal Generator	SMB 100A	177621	R&S	1 year	Mar-17
40	EFT Simulator	FNS-AX2	4000B01332	NoiseKen	1 year	Sep-16
41	Capacitive Coupling Clamp	CDN 8015	21240	SCHAFFNER	1 year	Sep-16
42	LIGHTNING SURGE SIMULATOR	LSS-6030	LSS02X0153	NOISEKEN	1 year	Sep-16
43	R-BOX (4x1000 HM)	INA 172	SL403-109	SCHAFFNER	1 year	-
44	CDN	CDN 117	20985	SCHAFFNER	1 year	-
45	CDN	CDN 118	20082	SCHAFFNER	1 year	-
46	Signal generator	SML03	103026/0013	R&S	1 year	Mar-17
47	POWER METER	NRVD	101689	R&S	1 year	Mar-17
48	RF Power Amplifier	FLL75A	1033	FRANKONIA	1 year	Dec-16
49	EM INJECTION CLAMP	TSIC-23	529	F.C.C	1 year	Jun-17
50	CDN (M1)	TSCDN-M1-16A	7004	F.C.C	1 year	Sep-16
51	CDN (M2)	TSCDN-M2-16A	7008	F.C.C	1 year	Sep-16
52	CDN (M3)	TSCDN-M3-16A	7017	F.C.C	1 year	Sep-16
53	Coil	INA 702	132	SCHAFFNER	6 month	Apr-17
54	Magnetic Field Generator	MFO6502	34267	SCHAFFNER	6 month	Apr-17
55	Modula System	MODULA6100	34395	SCHAFFNER	1 year	Sep-16
56	TRILOG Antenna	VULB9168	577	SCHWARZBECK	2 year	Mar-17
57	Compact Generator	NX5	P1640185038	EMTEST	1 year	May-17
58	AC Power Source	Variac NX1-260-16	P1648188071	EMTEST	1 year	May-17
59	Capacitive Coupling Clamp	CCI	P1703190739	EMTEST	1 year	Nov-17

APPENDIX B

PERFORMANCE CRITERIA

Performance criteria

The variety and the diversity of the apparatus within the scope of this document makes it difficult to define precise criteria for the evaluation of the immunity test results.

If as a result of the application of the tests defined in this standard, the apparatus becomes dangerous or unsafe then the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance by the manufacture and noted in the test report, based on the following criteria:

Electrostatic discharge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Radiated electromagnetic fields

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m, providing.

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable setting etc.)

(b) at 3 V/m, any deterioration of the picture is so minor that the system could still be used; and

(c) there is no observable deterioration of the picture at 1 V/m.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Fast transient burst / slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the surges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Conducted RF immunity

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at $U_0 = 130 \text{ dB}\mu\text{V}$.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at $U_0 = 140 \text{ dB}\mu\text{V}$, providing

-
- (a) there is no permanent damage or change to the EUT
(e.g. no corruption of memory or changes to programmable settings, etc.)
- (b) at $U_0 = 130 \text{ dB}\mu\text{V}$, any deterioration of the picture is so minor that the system could still be used, and
- (c) there is no observable deterioration of the picture at $U_0 = 120 \text{ dB}\mu\text{V}$.
- The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Voltage dip/interruption / Voltage variation

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Mains supply voltage variations

There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), during the conditioning.

APPENDIX C

Measurement Uncertainty

1. Conducted Emission

2. Radiated Emission

1. Conducted Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)	Standard
		9 kHz – 30 MHz	
Cable loss(RG400)	Standard Deviation(SD)	± 0.061	10 th measurement
Receiver corrections; -Sine wave voltage -Pulse amplitude response -Pulse repetition rate response	Rectangular ($\sqrt{3}$) Rectangular ($\sqrt{3}$) Rectangular ($\sqrt{3}$)	± 0.17 ± 0.02 ± 0.58	Cal. Report Cal. Report Cal. Report
LISN corrections (ENV216) ; -Voltage division factor	Normal (k = 2)	± 0.09	Cal. Report
Mismatch ; - Receiver VRC* : $\Gamma_i = 0.09$ -LISN VRC : $\Gamma_g = 0.14(150\text{kHz})$ = $0.05(30\text{MHz})$ - Uncertainty: $20\log(1 \pm \Gamma_i \Gamma_g)$	U-type($\sqrt{2}$)	± 0.89	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.28	10 th measurement
Combined measurement uncertainty Uc(y)	Normal	+ 0.73 - 0.73	
Expended measurement uncertainty (95.%,Confidence level,k = 2)dB	Normal(k = 2)	+ 1.46 - 1.46	

2. Below 1 GHz Radiated Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)		Standard
		Trilog		
		3m	10m	
Antenna Factor (VULB 9160)	Normal (k = 2)	30 MHz – 1 GHz	30 MHz – 1 GHz	ANT Cal. uncertainty
		± 2.00	± 2.00	
Cable loss (HFB-5010/HFC12D)	Standard Deviation(SD)	± 0.14	± 0.14	10 th measurement
Receiver corrections; -Sine Wave Voltage -Pulse amplitude response -Pulse repetition rate response	Normal (k = 2)	± 0.17	± 0.17	Cal. Report Cal. Report CISPR16-4-2
	Normal (k = 2)	± 0.58	± 0.58	
	Rectangular(√ 3)	± 1.50	± 1.50	
Antenna Directivity	Rectangular(√ 3)	± 1.00	± 1.00	CISPR16-4-2
AF Height Dependence	Rectangular(√ 3)	± 0.10	± 0.10	CISPR16-4-2
Phase Center Location	Rectangular(√ 3)	± 0.20	± 0.20	CISPR16-4-2
Separation Distance	Rectangular(√ 3)	± 0.30	± 0.30	CISPR16-4-2
Uncertainty of Site	Triangular(√ 6)	± 2.97	± 2.97	NSA
Mismatch ; - Receiver VRC* : Γi = 0.09 -ANT. VRC : Γg = 0.09 - Uncertainty: 20log(1± Γi Γg)	U-type (√ 2)	± 0.54	± 0.54	CISPR16-4-2
Pre-amp.	Normal (k = 2)	± 0.14	± 0.14	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.60	± 0.60	10 th measurement
Combined measurement uncertainty Uc(y)	Normal	+ 1.97 - 1.97	+ 1.97 - 1.97	
Expended measurement uncertainty (95%,Confidence level,k=2)dB	Normal(k = 2)	30 MHz – 1 GHz + 3.94 - 3.94	30 MHz – 1 GHz + 3.94 - 3.94	

Note:VRC(Voltage Reflection Coefficient)

3. Above 1 GHz Radiated Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)	Standard
		HORN	
Antenna Factor (ETS 3115)	Normal (k=2) (normal)	1 GHz - 6 GHz ± 1.00	ANT Cal. uncertainty
Cable loss (SUHNER MULTIFLEX microwave cables)	Standard Deviation(SD)	± 0.32	10 th measurement
Receiver corrections; -Sine Wave Voltage -Pulse amplitude response -Pulse repetition rate response	Normal (k = 2) Normal (k = 2) Rectangular($\sqrt{3}$)	± 0.17 ± 0.58 ± 1.50	Cal. Report Cal. Report CISPR16-4-2
Antenna Directivity	Rectangular($\sqrt{3}$)	± 1.00	CISPR16-4-2
AF Height Dependence	Rectangular($\sqrt{3}$)	± 0.10	CISPR16-4-2
Phase Center Location	Rectangular($\sqrt{3}$)	± 0.20	CISPR16-4-2
Separation Distance	Rectangular($\sqrt{3}$)	± 0.30	CISPR16-4-2
Uncertainty of Site	Standard Deviation(SD)	± 0.13	SVSWR 10 th measurement
Mismatch ; - Receiver VRC* : $\Gamma_i = 0.09$ -ANT. VRC : $\Gamma_g = 0.09$ - Uncertainty: $20\log(1 \pm \Gamma_i \Gamma_g)$	U-type ($\sqrt{2}$)	± 0.54	CISPR16-4-2
Pre-amp.	Normal (k = 2)	± 0.60	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.34	10 th measurement
Combined measurement uncertainty $U_c(y)$	Normal	+ 1.73 - 1.73	
Expended measurement uncertainty (95%,Confidence level,k=2)dB	Normal(k = 2)	1 GHz - 6 GHz + 3.46 - 3.46	

Note:VRC(Voltage Reflection Coefficient)

APPENDIX D

PHOTOGRAPHS

Conducted emission (Maximum emission configuration) / Recording (AC) mode



Conducted emission (Maximum emission configuration) / Recording (DC) mode



Conducted emission (Maximum emission configuration) _ TEL / Recording (AC) mode



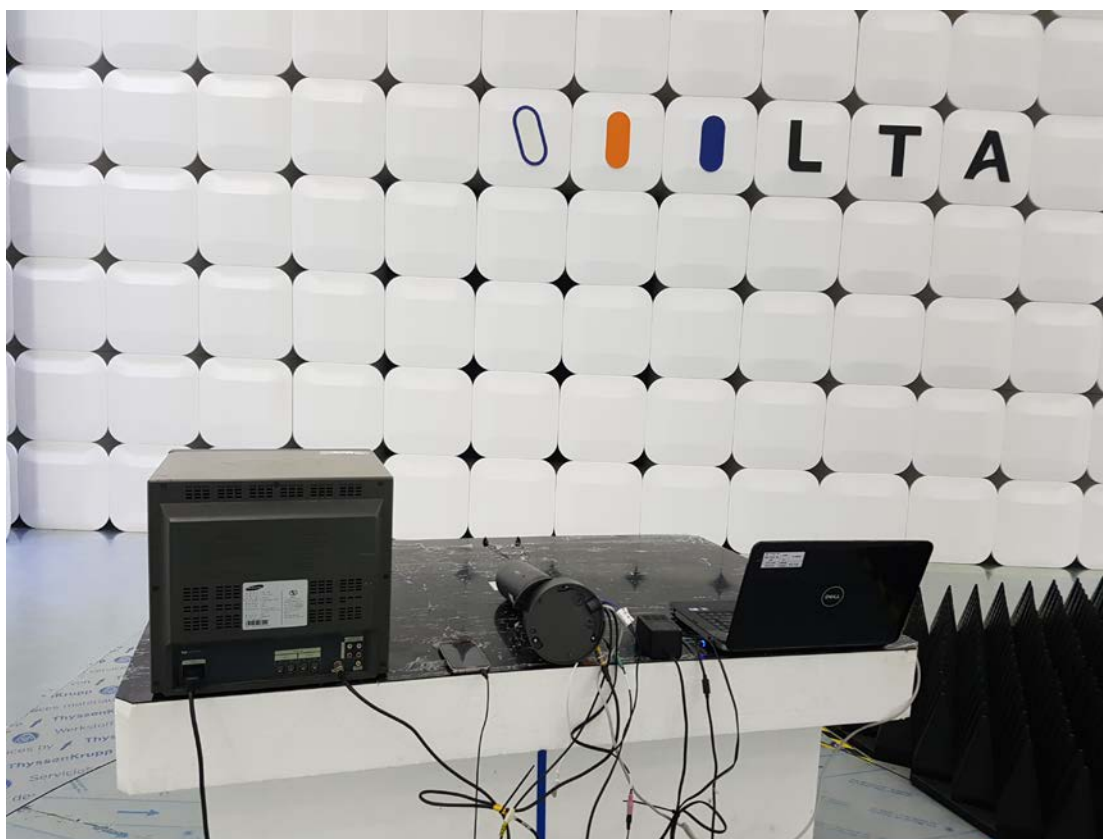
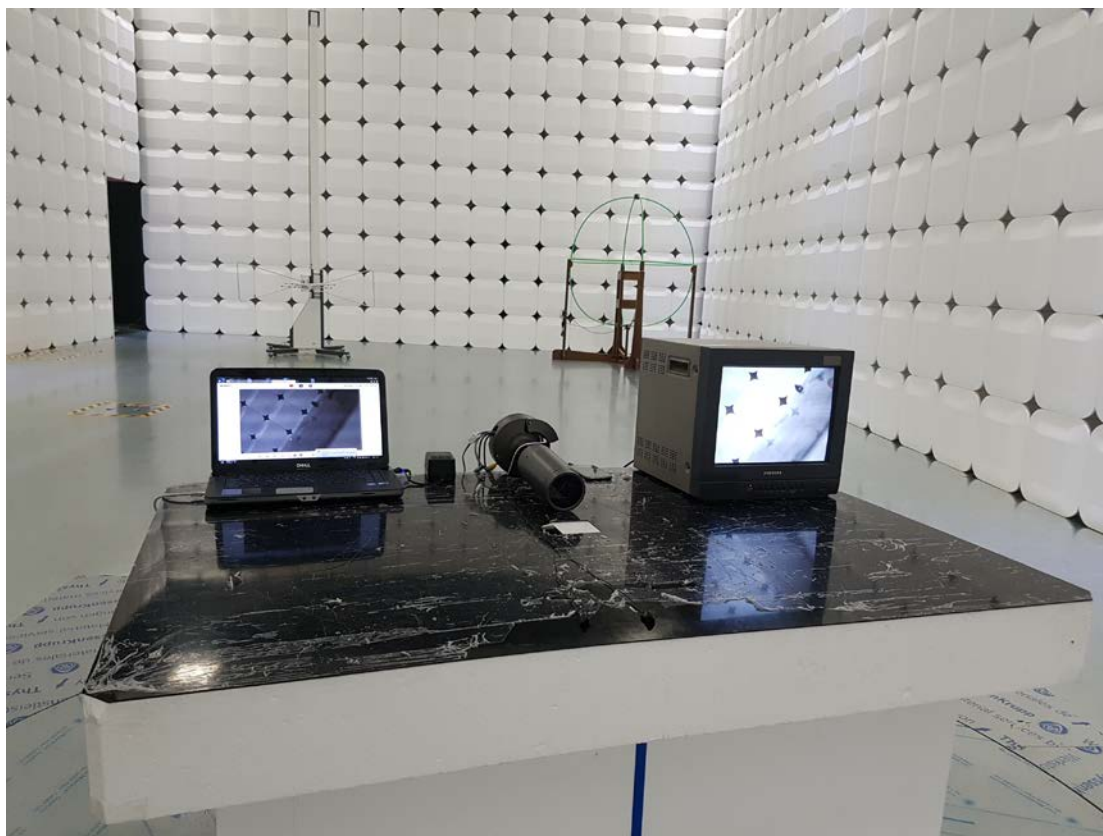
Conducted emission (Maximum emission configuration) _ TEL / Recording (DC) mode



Conducted emission (Maximum emission configuration) _ TEL / Recording (PoE) mode



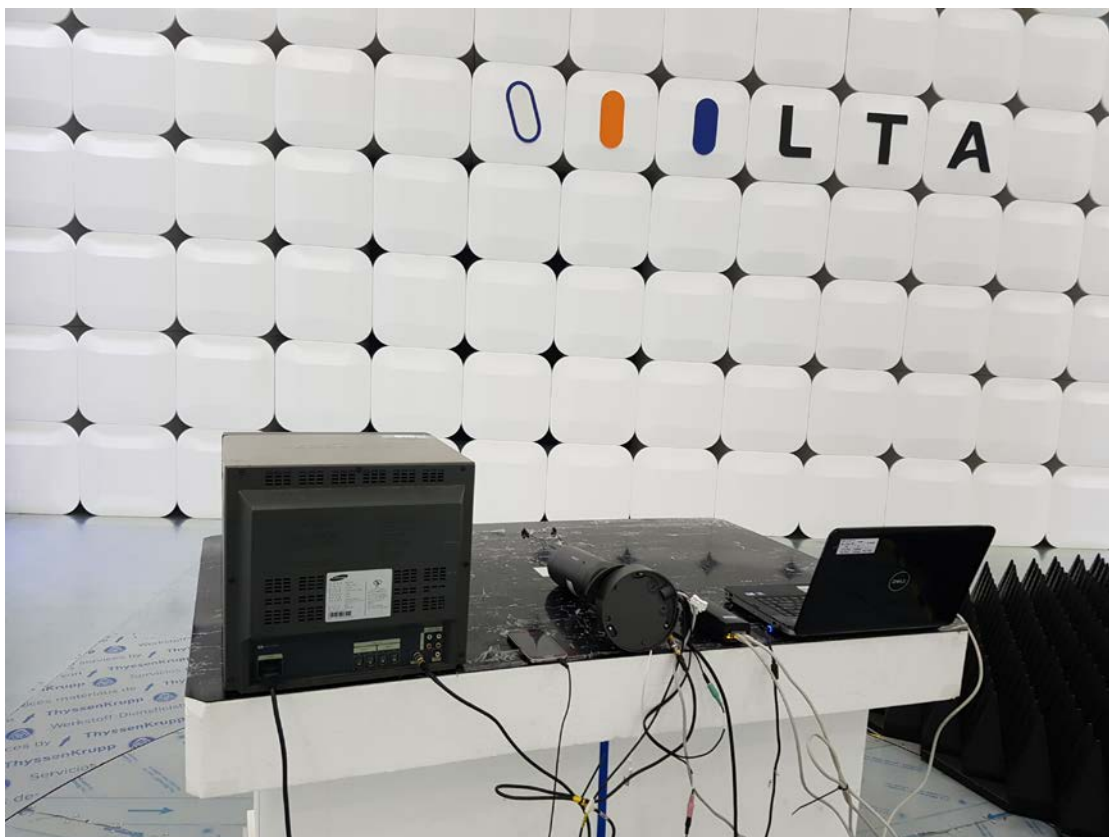
Radiated emission (Maximum emission configuration)-Below 1 GHz / Recording (AC) mode



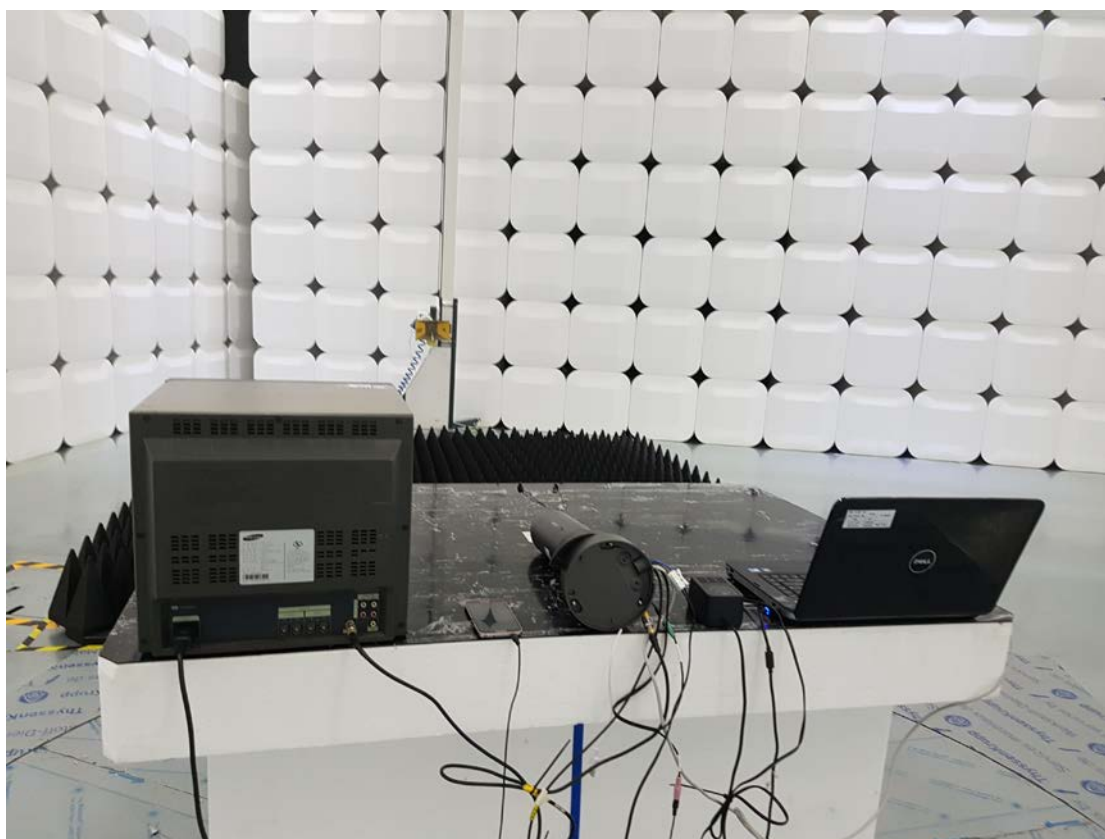
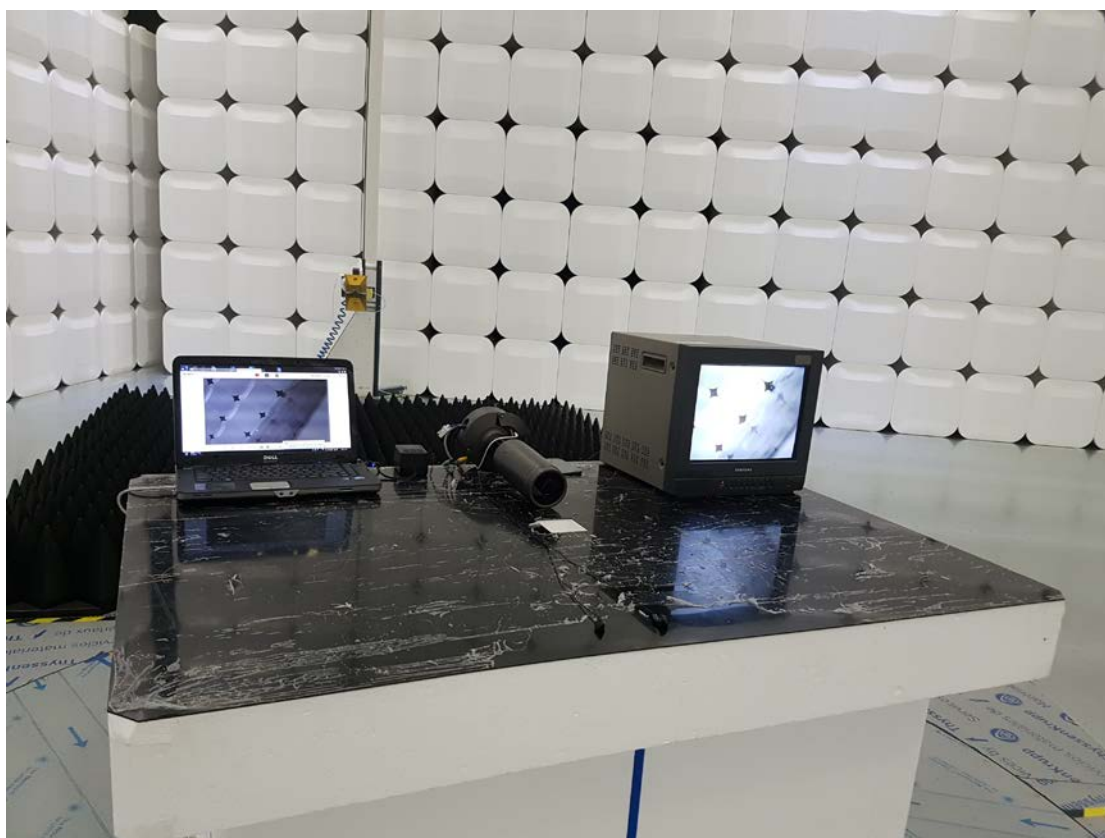
Radiated emission (Maximum emission configuration)-Below 1 GHz / Recording (DC) mode



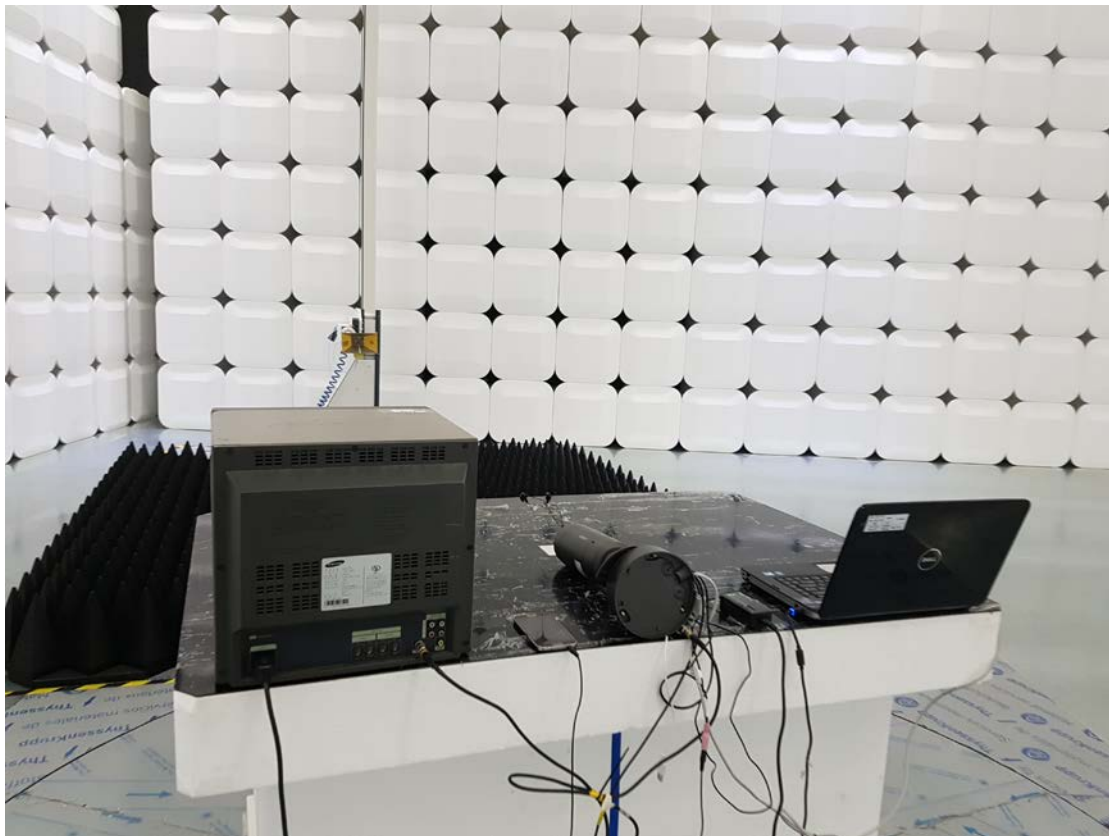
Radiated emission (Maximum emission configuration)-Below 1 GHz / Recording (PoE) mode



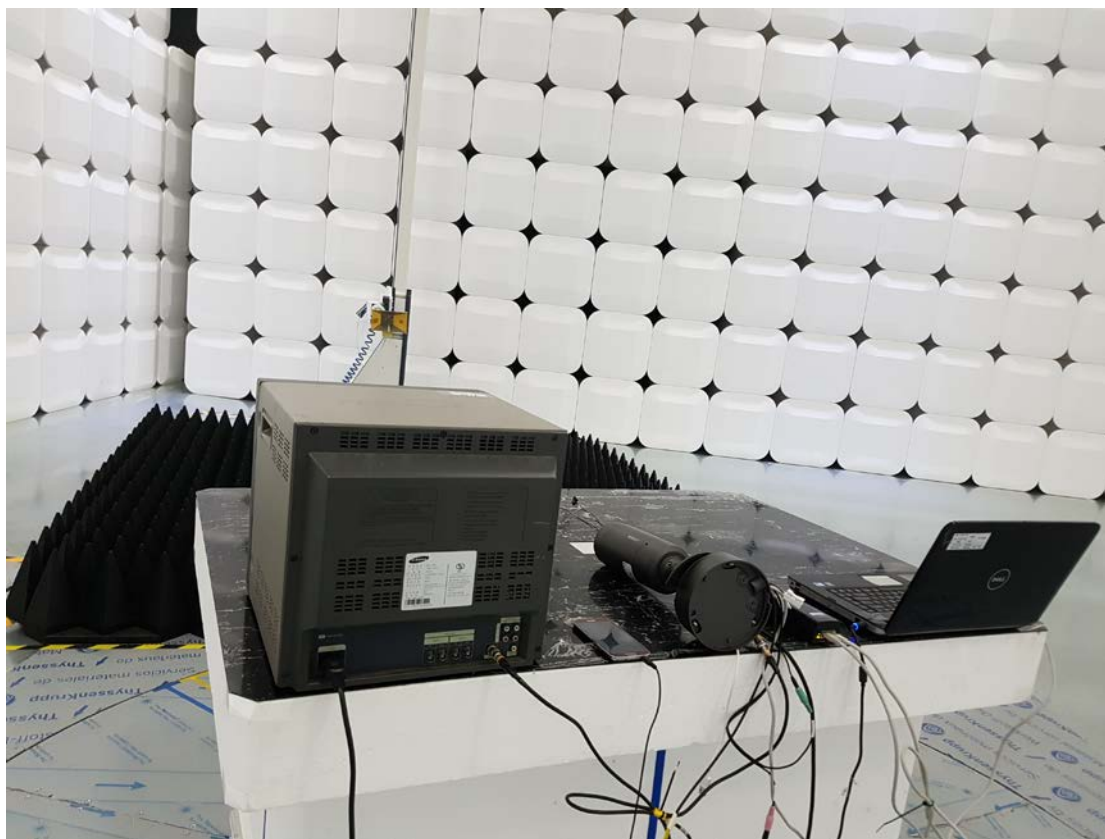
Radiated emission (Maximum emission configuration) – Above 1GHz / Recording (AC) mode



Radiated emission (Maximum emission configuration) – Above 1GHz / Recording (DC) mode



Radiated emission (Maximum emission configuration) – Above 1GHz / Recording (PoE) mode



Harmonic Current/Voltage Variation and Flicking / Recording (AC) mode



Harmonic Current/Voltage Variation and Flicking / Recording (DC) mode



Electrostatic discharge / Recording (AC) mode



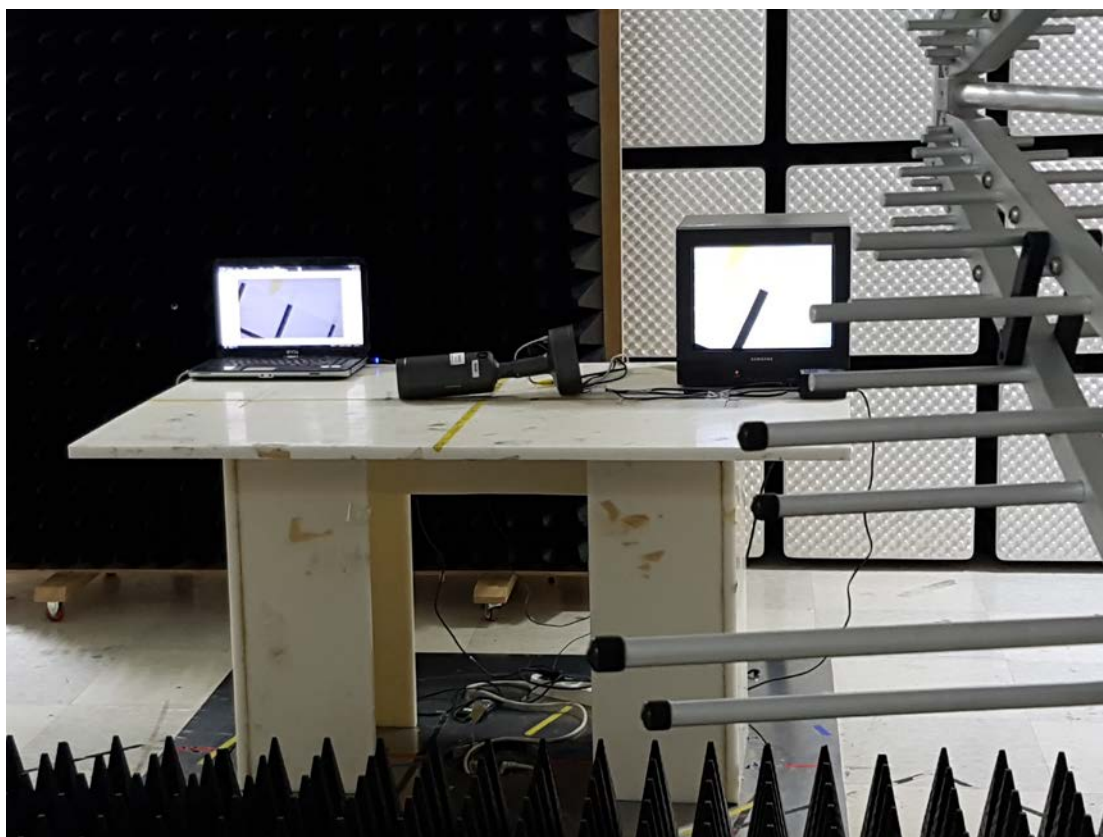
Electrostatic discharge / Recording (DC) mode



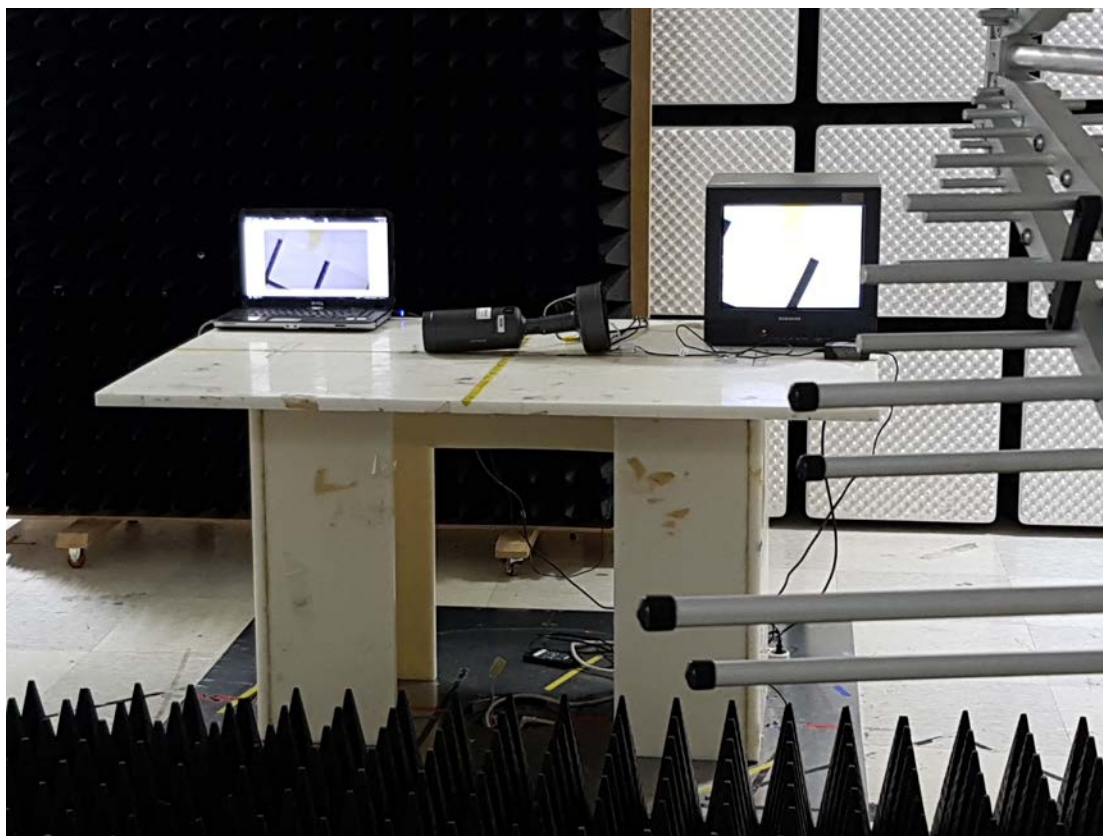
Electrostatic discharge / Recording (PoE) mode



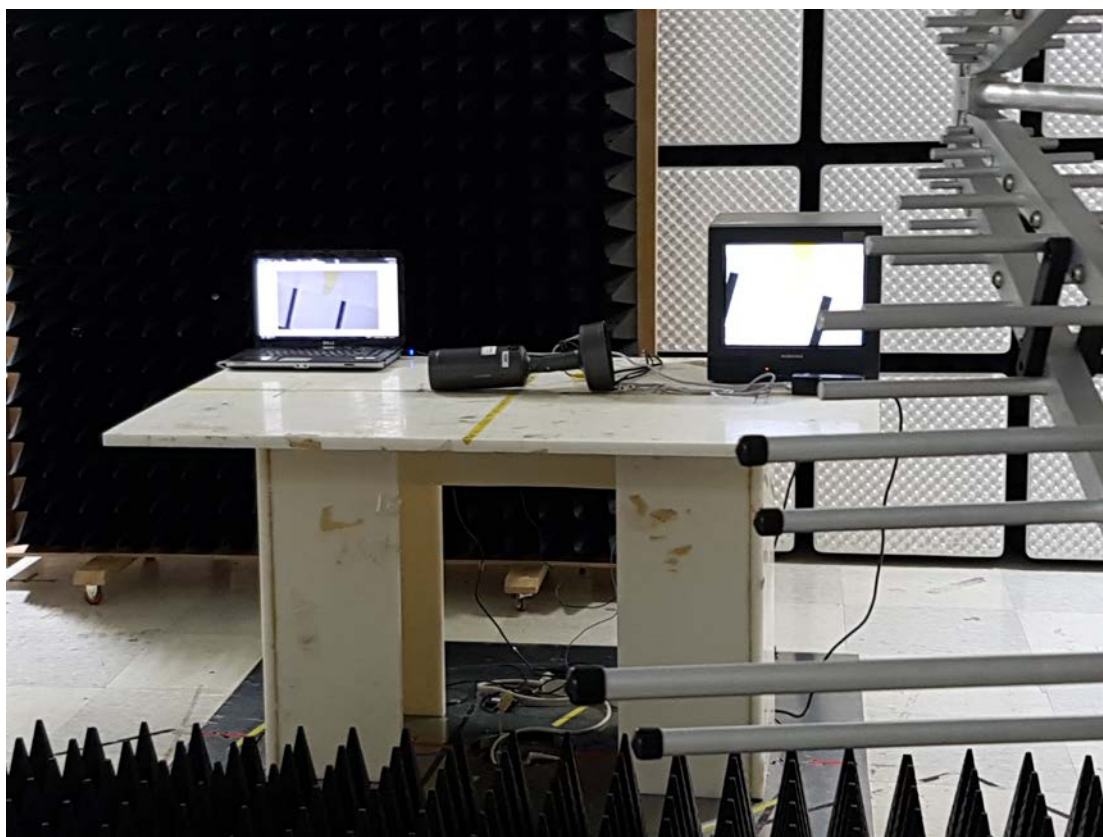
RF Electromagnetic Field / Recording (AC) mode



RF Electromagnetic Field / Recording (DC) mode



RF Electromagnetic Field / Recording (PoE) mode



Electrical fast transients / Recording (AC) mode



Electrical fast transients / Recording (DC) mode



Electrical fast transients / Recording (PoE) mode



Surge / Recording (AC) mode



Surge / Recording (DC) mode



Surge / Recording (PoE) mode



Conducted Disturbances, Induced by Radio-Frequency Fields / Recording (AC) mode



Conducted Disturbances, Induced by Radio-Frequency Fields / Recording (DC) mode



Conducted Disturbances, Induced by Radio-Frequency Fields / Recording (PoE) mode



Main supply voltage dips, short interruptions / Recording (AC) mode



Main supply voltage dips, short interruptions / Recording (DC) mode



Main supply voltage dips, short interruptions / Recording (PoE) mode



EUT



EUT



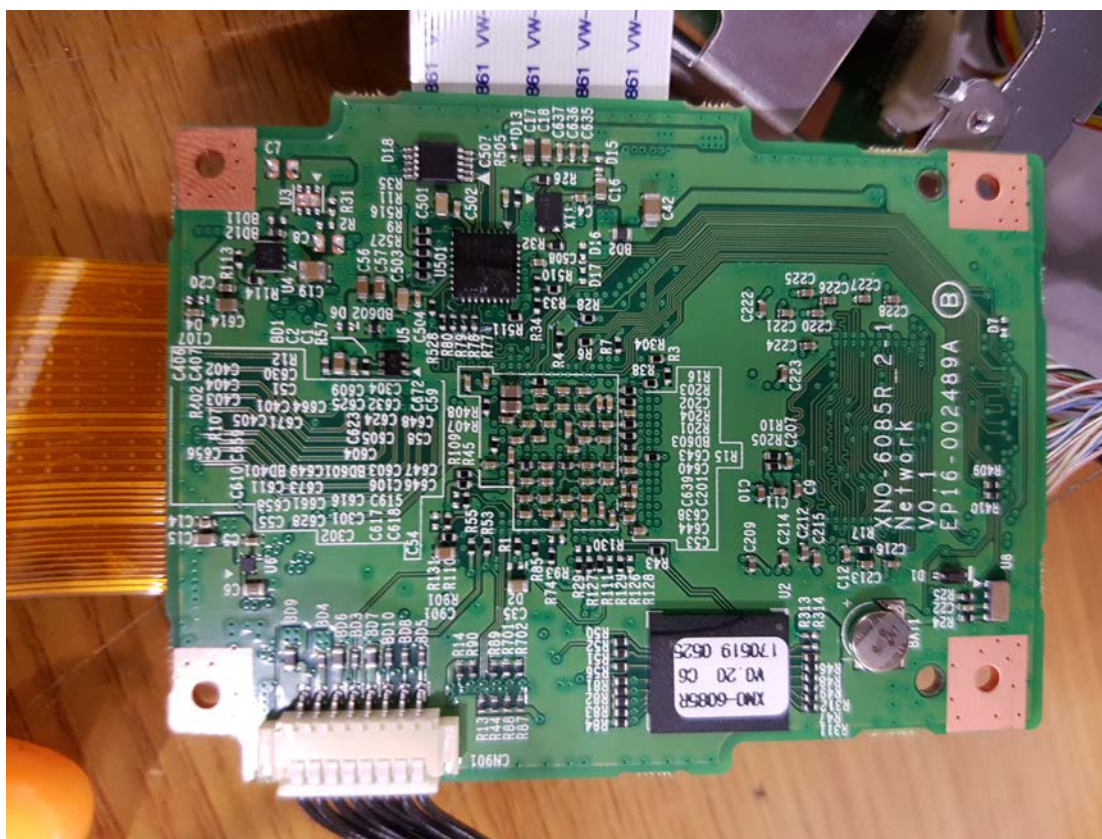
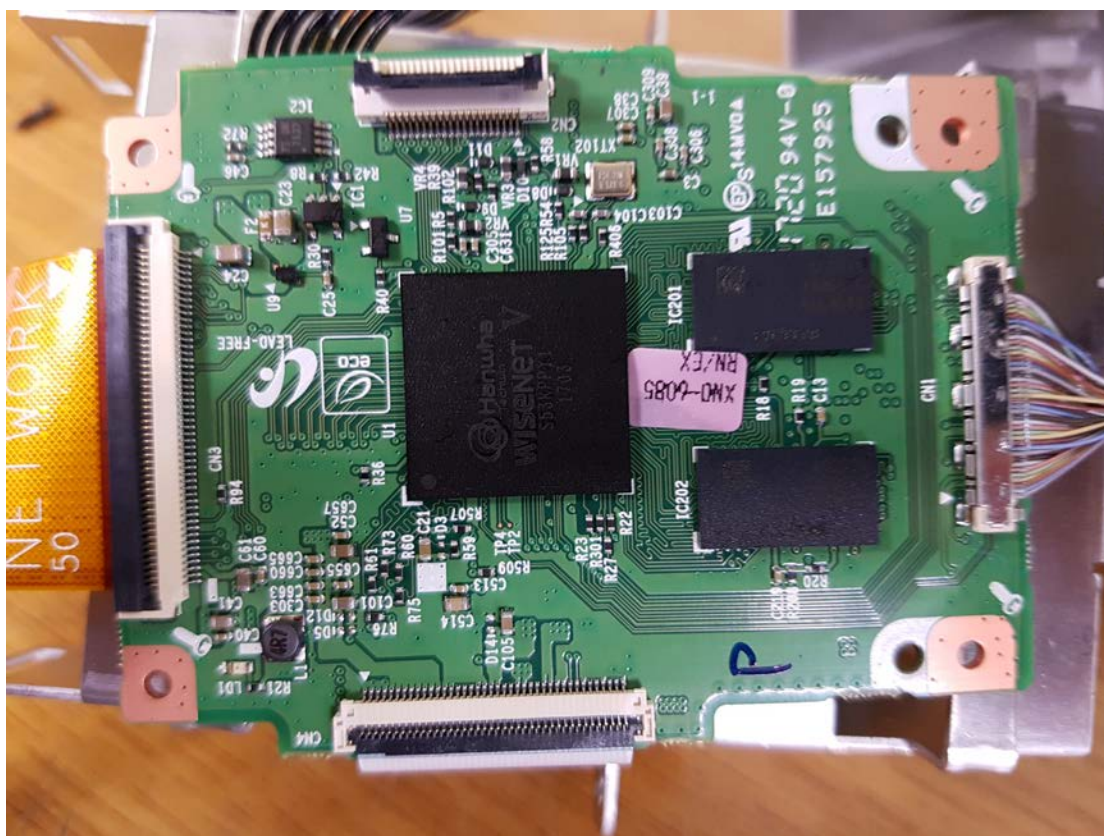
EUT



EUT



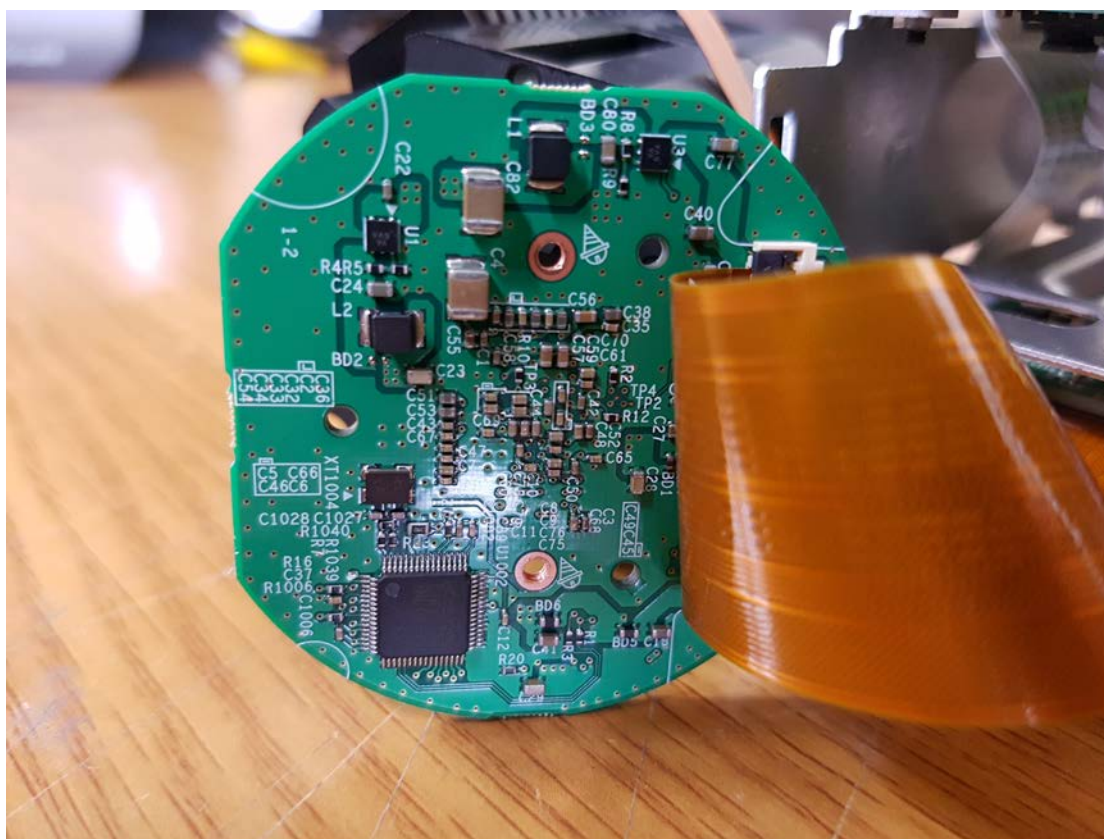
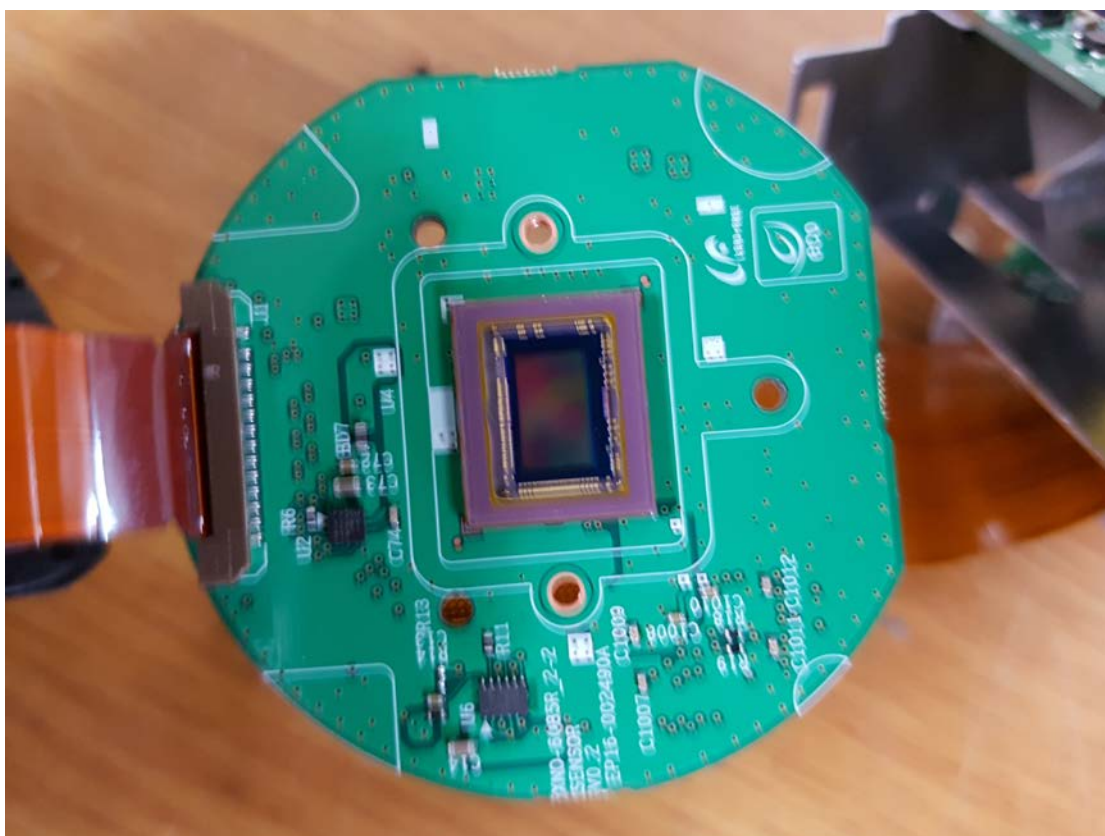
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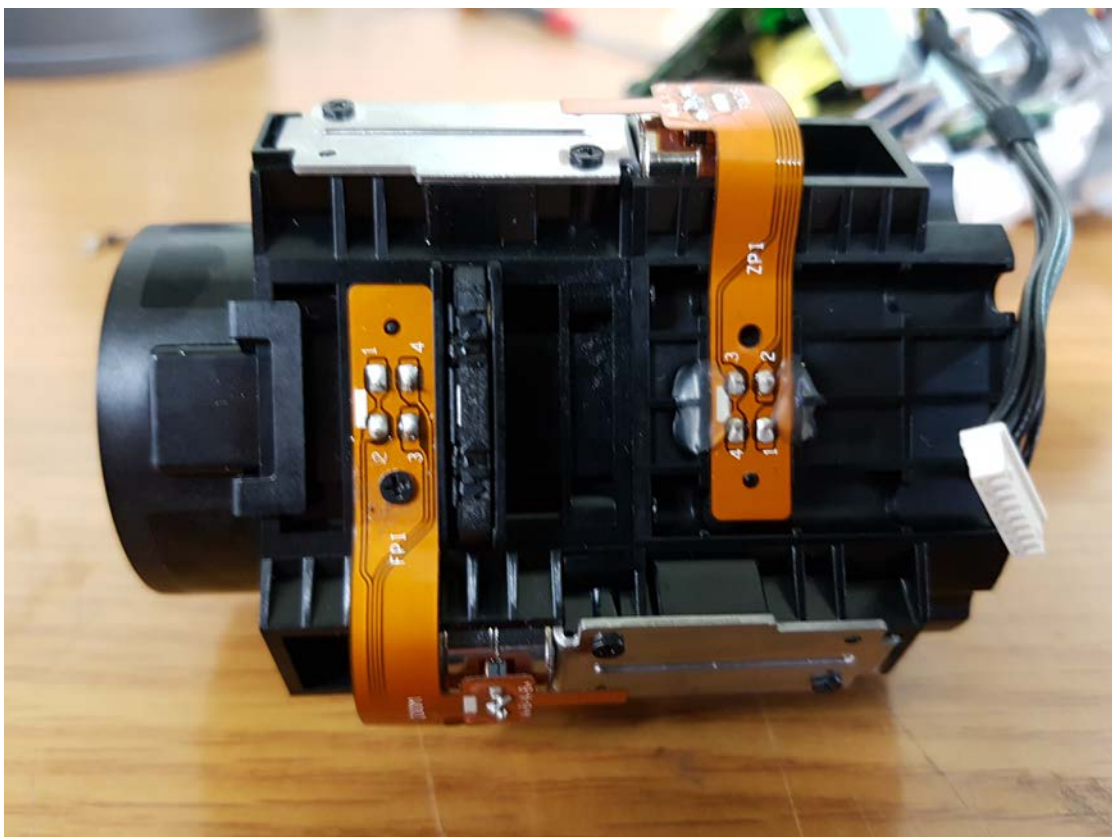
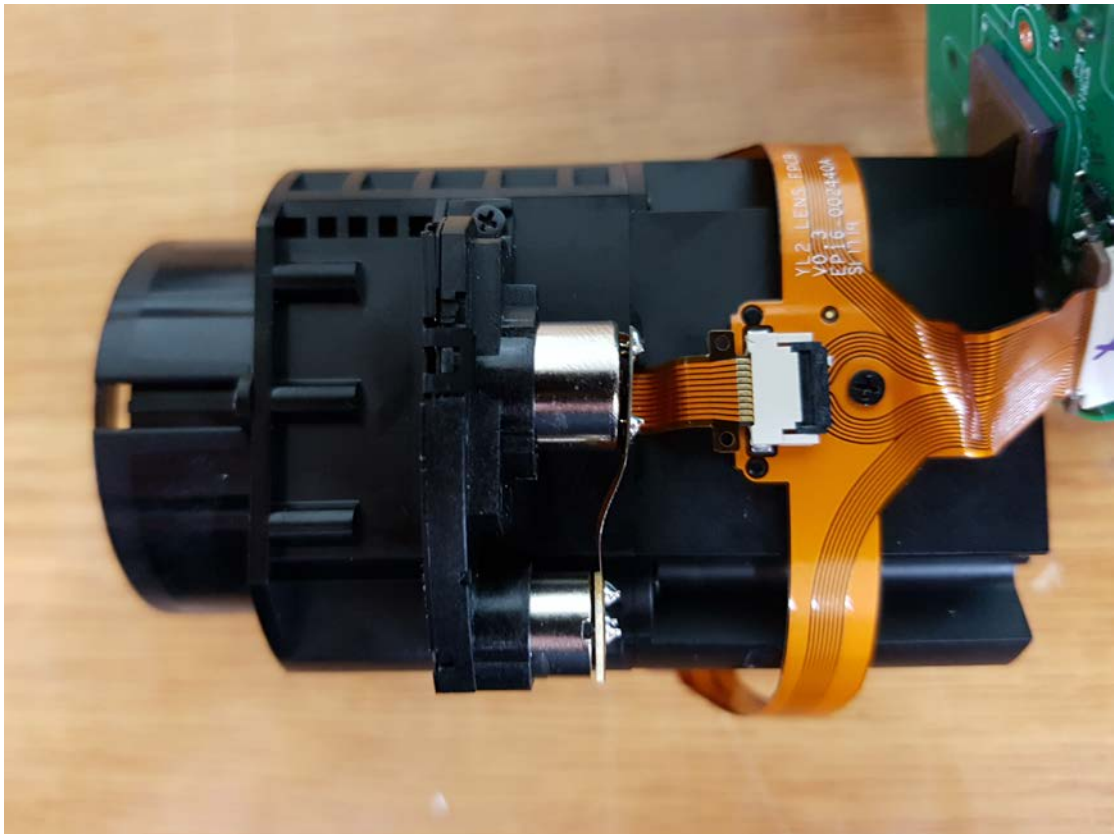
EUT



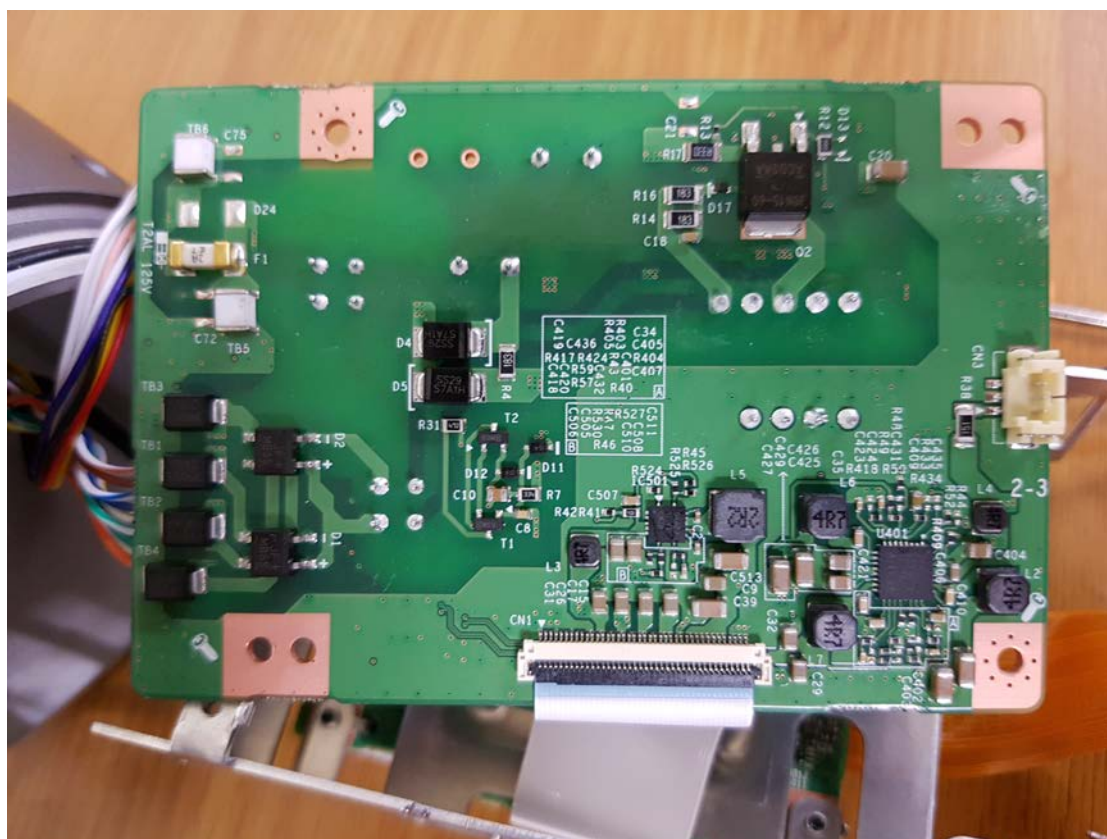
EUT



EUT



EUT



EUT

